# 4200A-SCS Parameter Analyzer

## Datasheet





## KEITHLEY A Tektroniy Company

See your innovations come to life. The 4200A-SCS is a customizable and fully-integrated parameter analyzer that provides synchronized insight into current-voltage (I-V), capacitance-voltage (C-V), and ultra-fast pulsed I-V characterization. The highest performance parameter analyzer, the 4200A-SCS accelerates semiconductor, materials, and process development.

The 4200A-SCS Clarius™ GUI-based Software provides clear, uncompromised measurement and analysis capability. Furnished with embedded measurement expertise and hundreds of ready-to-use application tests, Clarius Software enables you to dig deeper into your research with speed and confidence.

The 4200A-SCS Parameter Analyzer is completely customizable and fully upgradable, so you can add the instruments you need now – or later. With the 4200A-SCS Parameter Analyzer, making connections to your bold discoveries has never been easier.

## **Key Performance Specifications**

#### I-V Source Measure Units (SMUs)

- ±210 V/100 mA or ±210 V/1 A modules
- 100 fA measure resolution
- 10 aA measure resolution with optional preamp
- 10 mHz 10 Hz very low frequency capacitance measurements
- 100 µF load capacitance
- 4-quadrant operation
- 2 or 4-wire connections

#### C-V Multi-frequency Capacitance Units (CVUs)

- AC impedance measurements (C-V, C-f, C-t)
- 1 kHz 10 MHz frequency range
- ±30 V (60 V differential) built-in DC bias, expandable to ±210 V (420 V differential)
- Simple switching between I-V and C-V measurements with the optional CVIV Multi-Switch

#### Pulsed I-V Ultra-fast Pulse Measure Unit (PMU)

- Two independent or synchronized channels of high-speed pulsed I-V source and measure
- 200 MS/s, 5 ns sampling rate
- ±40 V (80 V<sub>p-p</sub>), ±800 mA
- Transient waveform capture mode
- Arbitrary waveform generator for multi-level pulse waveform with 10 ns programmable resolution

#### High Voltage Pulse Generator Unit (PGU)

- Two channels of high-speed pulsed V source
- ±40 V (80 V<sub>p-p</sub>), ±800 mA
- Arbitrary waveform generator Segment ARB® mode for multi-level pulse waveform with 10 ns programmable resolution

#### I-V/C-V Multi-Switch Module (CVIV)

- Easily switch between I-V and C-V measurements without re-cabling or lifting prober needles
- Move the C-V measurement to any terminal without re-cabling or lifting prober needles
- ±210 V DC bias capable

#### Remote Preamplifier/Switch Module (RPM)

- Automatically switches between I-V, C-V, and ultra-fast pulsed I-V measurements
- Extends current sensitivity of the 4225-PMU to tens of picoamps
- Reduces cable capacitance effects



Datasheet 4200A-SCS Parameter Analyzer

# The Ultimate Parameter Analyzer for Materials, Semiconductor Devices and Process Development

Perform I-V, C-V and pulsed I-V characterization with speed, clarity and confidence with the powerful Clarius software.



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## 4200A-SCS Instruments and Modules

| Model       | Description                                     | Key Measurements  | Range   | Measure Resolution                   |  |
|-------------|---|---|---|--------------------------------------|--|
| 4200-SMU    | Medium Power<br>Source-Measure Unit             |   | ±100 mA, ±210 V   |                                      |  |
| 4201-SMU    | Medium Power SMU with increased low I stability | . 5017  | ±100 MA, ±210 V   | 0.0.1/ 100.60                        |  |
| 4210-SMU    | High Power<br>Source-Measure Unit               | DC I-V     Very Low Frequency C-V     QSCV                            | .1 A .210 V   | - 0.2 μV, 100 fA                     |  |
| 4211-SMU    | High Power SMU with increased low I stability   | - Q30V  | ±1 A, ±210 V  |                                      |  |
| 4200-PA     | Remote Preamplifier<br>Module                   |   | Extends current ranges for all SMUs   | 0.2 μV, 10 aA                        |  |
| 4210-CVU    | Capacitance-Voltage Unit                        | • AC Impedance<br>• C-V, C-f, C-t                                     | 1 kHz – 10 MHz     ±30 V built-in DC bias     (60 V differential)     ±210 V DC bias with SMUs     100 mV AC drive  | 1 aF, 1 nS,<br>0.001 degree          |  |
| 4215-CVU    | High Resolution<br>Capacitance-Voltage Unit     | AC Impedance     C-V, C-f, C-t  | 1 kHz – 10 MHz     ±30 V built in DC bias (60 V differential)     ±210 V DC bias with SMUs     1 V AC drive   | 1 kHz<br>1 aF, 1 nS,<br>0.001 degree |  |
| 4200A-CVIV  | I-V/C-V Multi-Switch Module                     | DC I-V and C-V with<br>Automatic Switching                            | _   | _                                    |  |
| 4225-PMU    | Ultra-Fast Pulse Measure Unit                   | Pulsed I-V SegmentARB® Multi-level Pulsing Transient Waveform Capture | ±40 V (80 V <sub>p-p</sub> ), ±800 mA     200 MS/s simultaneous I and V measure     2048 unique segments     20 ns PW source only     60 ns PW source/measure | 75 nA                                |  |
| 4225-RPM    | Remote Preamplifier/<br>Switch Module           | Enables automatic switching<br>between SMU, CVU and PMU               | Extends current range of 4225-PMU unit  | 200 pA                               |  |
| 4220-PGU    | High Voltage Pulse<br>Generator Unit            | Pulsed Voltage Source     SegmentARB®     Multi-level Pulsing         | • ±40 V (80 V <sub>p-p</sub> )<br>• 2048 unique segments  | _                                    |  |
| Ground Unit | Built-in, Low Noise Ground Unit                 | _   | <ul><li>Triaxial connection: 2.6 A</li><li>Binding post: 9.5 A</li></ul>  | _                                    |  |

# Example List of Extracted or Measured Parameters

| CMOS transistor     | Id-Vg, Id-Vd, Ig-Vg, Vth, Vtlin, Sub-Vt, Rds-on, breakdown, capacitance, QSCV, Low-frequency CV, self-heating reduction and more |
|---------------------|--|
| BJT                 | Ic-Vc, Vcsat, Gummel plot, capacitance, $\beta F$ , $\alpha F$   |
| Non-volatile Memory | Vth, endurance test, capacitance   |
| Nanoscale           | Resistance, Id-Vg, Id-Vd, Ic-Vc  |
| Discrete components | Id-Vg, Id-Vd, Ic-Vc, V <sub>fdiode</sub> , V <sub>rdiode</sub> , capacitance   |
| Materials           | Van der Pauw, 4-point collinear resistivity, Hall Effect   |
| Photovoltaics       | I <sub>forward</sub> , I <sub>reverse</sub> , HiR, LoR   |
| Power device        | Pulsed Id-Vg, pulsed Id-Vd, breakdown  |
| Reliability         | NBTI/PBTI, charge pumping, hot carrier injection, V-Ramp, J-Ramp, TDDB   |

## 1. Clarius Software

Take your research to new levels of understanding with the new Clarius Software user interface. The 4200A-SCS includes the Clarius+ software package, which allows peforming nearly any type of I-V, C-V, and pulsed I-V characterization test. The Clarius Software user interface provides touch-and-swipe or point-and-click control for advanced test definition, parameter analysis, graphing, and automation capabilities for modern semiconductor, materials, and process characterization.

### **Key Features**

- Ready-to-use, modifiable application tests, projects and devices that reduce test development time
- Industry's first instrument with built-in measurement videos from world-wide Application engineers, in four languages, to reduce learning curve
- Pin to pad contact check ensures reliable measurements
- Select data from multiple tests and combine parameters into project-level analysis
- Data display, analysis and arithmetic functions

## **Reduce Characterization Complexity** with Expert Videos

Engage quickly with your application and reduce your learning curve by watching built-in videos from Keithley worldwide application engineers. Hours of expert measurement expertise help will guide you when unexpected results occur or questions arise on how to set up your test. All videos are provided in English, and many are translated into other languages including Chinese, Japanese, and Korean. These short expert videos enable quick insight to your bold discoveries.

#### Select from Ready-to-Use Application Tests

With over 450 furnished application tests in the Clarius library, select or modify the pre-defined application tests to accelerate your characterization or easily create custom tests from the beginning. With three easy steps, Clarius Software guides even the new user through parameter analysis like an expert.

#### Real-time Results and Parameters

Accelerate your time to insight with automated data display, arithmetic functions, analysis and real-time parameter extraction. Never worry about losing your data because all test history is stored.

## Verify Pulse Measurements without an Oscilloscope

Pulse timing preview mode provides an easy-to-read view of your pulse timing parameters that confirms your pulsed I-V test will execute as needed. Use the transient I-V or waveform capture mode to make time-based current or voltage measurements without the need of an external oscilloscope.

## Typical Applications

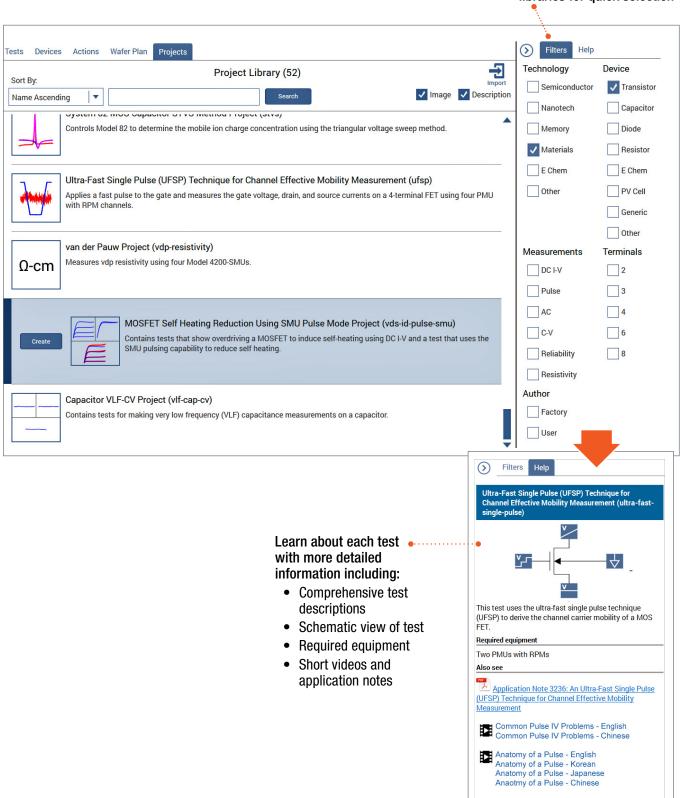
- Bio FETs and Sensors
- MOSFET, BJT Transistors
- Materials Characterization
- Non-volatile Memory Devices
- Resistivity & Hall Effect Measurements
- Interface Trap Density
- 1/f Noise Testing
- NBTI/PBTI
- III-V Devices
- Failure Analysis
- Nanoscale Devices
- Diodes and pn Junctions
- Solar Cells
- Sensors
- MEMS Devices
- Electrochemistry
- LED and OLED



## Step 1 - Build your Test Plan

Search, filter, and select from more than 450 pre-defined application tests, projects, and devices from the Clarius library.

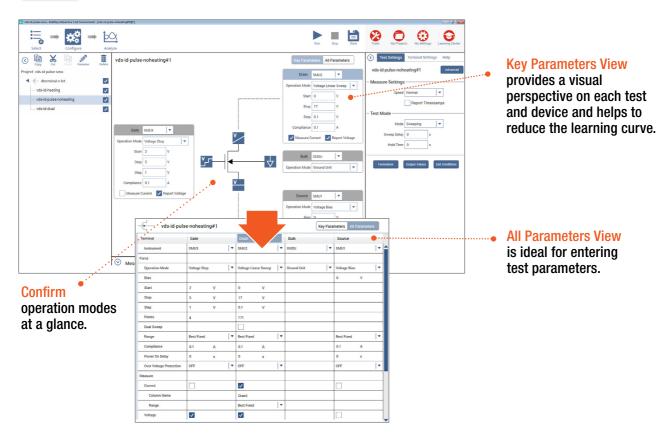
Filter test, device, or project libraries for quick selection





## Step 2 - Configure Your Tests

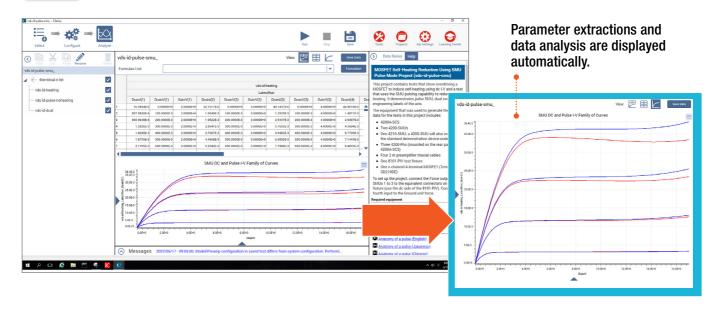
Quickly modify the test parameters using the Key Parameters View or All Parameters View.





## Step 3 - Analyze Results

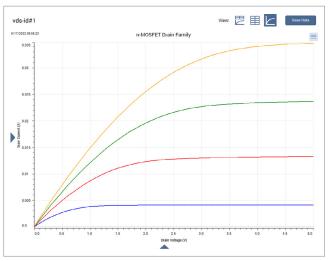
View results either graphically or numerically, filter your test data, and tag data for easy identification.



## 2. Source Measure Units (SMU)

Precision DC current vs. voltage (I-V) measurements are the cornerstone of device and materials characterization. World-class source measure unit (SMU) instruments are at the core of the 4200A-SCS Parameter Analyzer. A source measure unit can source either voltage or current and can simultaneously measure both voltage and current with high resolution and accuracy. The SMU integrates the voltage source, current source, ammeter and voltmeter in one instrument card for tight synchronization of I-V measurements.

A source measure unit has four-quadrant capability, which means it can not only source but also sinks current, as when taking current from a device under test (DUT), such as a charged capacitor or solar cell.



I-V sweep measurement.

The 4200A-SCS Parameter Analyzer can be configured with up to nine SMUs. Four SMU models are available: two medium power SMUs that have a range up to 210 V and 100 mA and two high power SMUs that have a range up to 210 V and 1 A. The 4201-SMU and 4211-SMU can source into a fixture with a load capacitance of up to 10  $\mu F$  and 100  $\mu F$  respectively depending on the current range.

All 4200A-SCS SMUs have shielded triaxial connections with active guarding for low current and high impedance measurements and 4-wire (Kelvin) force and sense connections.

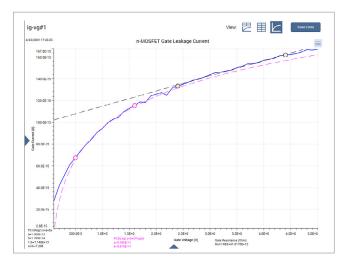
#### Field Installable SMUs

Need to replace or add SMUs to your existing 4200A-SCS mainframe? Now available, a first-in-class field installable SMU and SMU/PA. Eliminate the time-consuming requirement of returning your parameter analyzer to a service center just to add or replace SMUs. These distinct SMUs can be installed at your facility and will maintain their specifications over the standard one year calibration cycle.

#### Extend Measurement Resolution to 10 aA

Many critical applications demand the ability to measure very low currents – such as determining the gate leakage current of FETs, testing sensitive nano-scale devices, and measuring leakage current of insulators and capacitors.

When the SMUs are configured with the optional 4200-PA Remote Preamp, they are capable of exceptionally low current measurements. The 4200-PA provides 10 aA resolution by adding additional current ranges to either SMU model. To the user, the SMU simply appears to have additional measurement resolution available.

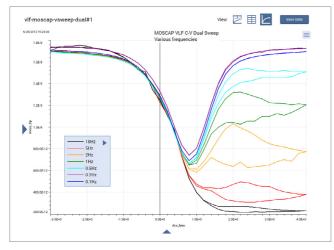


Sub-fA measurements with optional 4200-PA preamplifier module.

The preamplifier is shipped installed on the back of the 4200A-SCS mainframe. This installation allows for standard cabling to a prober, test fixture or switch matrix. The preamplifier can be removed from the back panel and placed in a remote location (such as in a light-tight enclosure or on a prober platen) to eliminate measurement problems due to long cables. Platen mounts and triax panel mount accessories are available.

## Very-low Frequency C-V Technique with SMUs

The 4200A-SCS offers the unique ability to perform very-low frequency capacitance-voltage measurements without an LCR meter or capacitance module. Low frequency C-V measurements are used to characterize the slow trapping and de-trapping phenomenon in some materials.



Very low frequency C-V measurements with SMUs and preamps.

The 4200A-SCS uses a new narrow-band technique that takes advantage of the low current measurement capability of the integrated SMU instruments to perform C-V measurements at specified low frequencies in the range of 10 mHz to 10 Hz. This approach uses the 4200A-SCS's SMUs with preamplifiers; no additional hardware or software is required.

#### **Local Switching Options**

To accommodate switching between I-V and other measurement types, the 4200A-SCS offers several options for switching easily between measurement types:

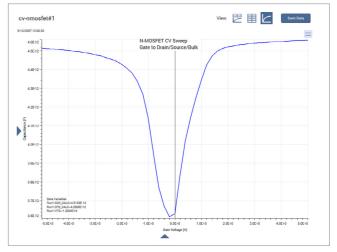
- 4200A-CVIV Multi-Switch Module up to four channels that effortlessly switch between I-V and C-V measurements. In addition, the C-V measurements can be moved around the device under test without lifting the prober needles or changing the test setup.
- 4225-RPM Remote Preamplifier/Switch Module acts as a multiplexer switch that automatically switches between precision DC SMUs, C-V, and the ultra-fast pulsed I-V instruments. In addition, the RPM extends the low current measurement capability of the 4225-PMU Ultra-fast Pulsed I-V Instrument Module.

## 3. Capacitance-Voltage Unit (CVU)

Capacitance-voltage (C-V) measurements are often used to characterize a MOSFET's gate oxide thickness, oxide defect density, doping profiles, etc. In this measurement, as the gate voltage varies, the capacitance of the gate to the drain and source changes. Capacitance measurements are typically made using an AC technique. The multi-frequency C-V instrument modules measure AC impedance by applying a DC bias voltage and sourcing an AC voltage across the device under test (DUT) and then measuring the resultant AC current and phase angle.

#### AC Measurements from 1 kHz - 10 MHz

Both the 4215-CVU and 4210-CVU instrument modules perform multi-frequency capacitance measurements from femtofarads (fF) to microfarads ( $\mu$ F) at test frequencies from 1 kHz to 10 MHz and while providing a DC bias voltage of up to  $\pm 30$  V or 60 V differential. The difference between the two CVUs are the number of test frequencies and the AC drive voltage. The 4215-CVU has 10,000 discreet frequencies with 1kHz resolution and the 4210-CVU has 37 discreet frequencies. The AC drive voltage range of the 4215-CVU is 10 mV to 1 V rms and the range of the 4210-CVU is 10 mV to 100 mV rms.



Capacitance-Voltage sweeps.

With up to 4096 measurement points, the CVU instrument can be used to measure capacitance vs. voltage (C-V), capacitance vs. frequency (C-f) and capacitance vs. time (C-t) to extract many important parameters such as:

- Doping profiles
- T<sub>OX</sub>
- Carrier lifetime tests
- Junction, pin-to-pin, and interconnect capacitance measurements

The 4200-CVU-PWR option is available to support:

- High power C-V measurements up to 400 V (200 V per device terminal) for testing high power devices, such as MEMS devices, LDMOS devices, and displays.
- DC currents up to 300 mA for measuring capacitance when a transistor is turned on.

## **Ensure Validity of your Results**

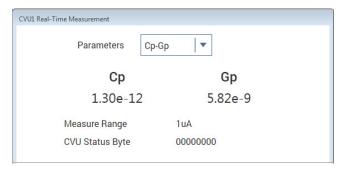
Unlike other C-V modules on the market, the 4210-CVU and 4215-CVU are designed with unique, patented circuitry to support features and diagnostic tools that ensure the validity of your results.

 Switch the AC ammeter in software. This simple feature ensures that you are measuring the AC signal on the least noisy terminal, which will provide a more useful measurement. Without having to manually change cables, lift the prober needles, or change the test setup, you have easily eliminated potential mistakes.

| AC Source V                               | CVH1    | ▼  |   |
|---|---------|----|---|
| AC Measure I Range(CVL1)                  | Auto    | •  |   |
| DC Source V                               | CVH1    | •  |   |
| DC Offset(CVL1)                           | 0       |    | V |
| I Max (Range)                             | 1mA     |    |   |
| Frequency                                 | 1MHz    |    |   |
| AC Drive Voltage                          | 20mV RN | 1S |   |
| $C_{Max} \approx \frac{I_{Ma}}{2\pi f V}$ |         |    |   |

Change AC and DC sources to least noisy terminal with a simple click of the mouse.

- Move the DC bias to the terminal of choice.
   With just a click in the Clarius Software, you can change the terminal to which the DC bias is applied to ensure proper control of the electric field.
- Real-time C-V meter. The real-time C-V meter displays quick and accurate capacitance measurements with no need to run a pre-programmed test. This is especially useful to ensure you have an open and short circuit before you perform a measurement compensation.
   Additionally, you can use the real-time C-V meter for troubleshooting your test setup and device under test.



Real-time capacitance measurements.

• Confidence Check. This diagnostic tool allows users to check the integrity of open and short connections and the connections to the DUT. When performing an open or short test, an impedance and noise measurement is made on the high and low sides of the test circuit. This is especially useful to confirm that contact has been made with the pads on a wafer or that the switch matrix is connected properly. If the Confidence check diagnostic test fails, additional troubleshooting guidance is given.

#### **Local Switching Options**

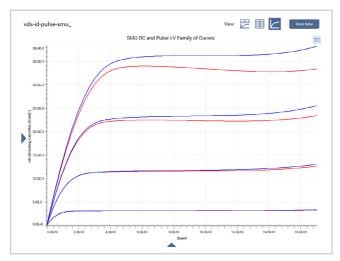
Because it can be difficult to switch between C-V and other measurement types, the 4200A-SCS offers several options to switch easily between measurement types:

- 4200A-CVIV Multi-Switch Module Up to four channels that effortlessly switch between I-V and C-V measurements. In addition, the C-V measurements can be moved around the DUT without lifting the prober needles or changing the test setup.
- 4225-RPM Remote Preamplifier/Switch Module
   This acts as a multiplexer switch that automatically switches between precision DC SMUs, C-V, and the ultra-fast pulsed I-V instruments. In addition, the RPM extends the low current measurement capability of the 4225-PMU Ultra-fast Pulsed I-V Instrument Module.

## 4. Ultra-fast Pulse Measure Unit (PMU)

Ultra-fast I-V sourcing and measuring have become increasingly important capabilities for many technologies, including compound semiconductors, medium power devices, non-volatile memory, MEMS devices and more.

The 4225-PMU instrument card integrates ultrafast voltage waveform generation and signal observation capabilities into the already-powerful 4200A-SCS test environment to deliver unprecedented I-V testing performance, expanding the system's materials, device, and process characterization dramatically. It replaces traditional pulse/measure hardware configurations, which typically included an external pulse generator, a multichannel oscilloscope, specially designed interconnect hardware, and integrated software.



Minimize self-heating effects with ultra-fast pulsed I-V.

Each module has two independent channels. Each channel can measure both voltage and current simultaneously with parallel 14-bit A/D converters with deep memory, allowing up to one million samples at 5 ns per sample (200 MS/s).

# Three Operating Modes for Complete Characterization

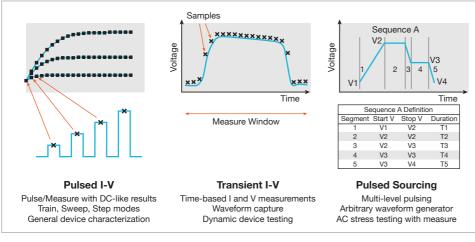
The 4225-PMU can be used to perform three types of ultra-fast I-V tests: pulsed I-V, transient I-V, and pulsed sourcing.

**Pulsed I-V** refers to any test with a pulsed source and a corresponding high speed, timed-based measurement that provides DC-like results. Using pulsed I-V signals to characterize devices rather than DC signals makes it possible to study or reduce the effects of self-heating (Joule heating) or to minimize current drift or degradation in measurements due to trapped charge.

**Transient I-V** or waveform capture is a time-based current and/or voltage measurement that is typically the capture of a pulsed waveform. A transient test is typically a single pulse waveform that is used to study time-varying parameters, such as the drain current degradation versus time due to charge trapping or self-heating. Transient I-V measurements can be made to test a dynamic test circuit or can be used as a diagnostic tool for choosing the appropriate pulse settings in the pulsed I-V mode.

**Pulsed Sourcing** involves outputting user-defined twolevel or multi-level pulses using the built-in Segment

ARB® function or outputting an arbitrarily defined waveform. When the instrument's Segment ARB mode is used for multilevel pulsing, individual voltage segments can be as short as 20 ns and waveforms can have up to 2048 unique segments per channel, which provides the flexibility necessary to build waveforms for characterizing flash devices and other nonvolatile memory technologies.



4225-PMU Operating Modes.

## 5. Switching Solutions

Tie it all together with your choice of high speed, high integrity switching solutions from Keithley.

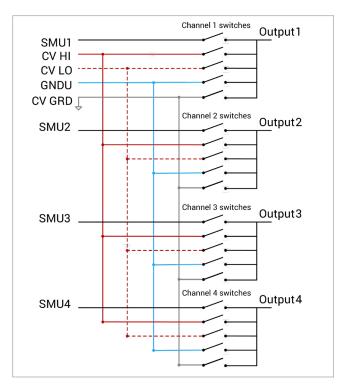
#### 4200A-CVIV Multi-Switch

One of the most difficult problems associated with integrating various measurements into device characterization is that the cabling required for each measurement type is fundamentally different.



4200A-CVIV Multi-Switch.

Matching cabling to the measurement type enhances measurement integrity. However, changing cables for each measurement type is so time-consuming many users simply tolerate the sub-optimal results. Moreover, whenever cables are rearranged, users run the risk of



4200A-CVIV Multi-Switch connection schematic.

reconnecting them improperly, thereby causing errors and demanding extra troubleshooting time. Worse still, these errors may go unnoticed for a long time.

One alternative is to use a remote switch capable of handling I-V and C-V signals, such as the Keithley 4200A-CVIV Multi-Switch.

The new 4200A-CVIV Multi-Switch automatically switches between I-V and C-V measurements. In addition, C-V measurements can be moved to any output channel without re-cabling. This four-channel switch allows the user to maintain the same impedance during the I-V and C-V tests by keeping the probe needles on the wafer test site. Additionally, the test setup and cables don't need to be changed to enhance the measurement.

The built-in display provides exceptional, clear test information where you need it, near the device under test.

- View real-time test status
- Personalize output naming convention via Clarius software
- Rubber bumpers allow 2-way orientation on probe station
- · Ability to rotate text allows user to orient the module as needed
- Turn off display to reduce light near DUT

#### 4225-RPM Remote Preamplifier/Switch Module

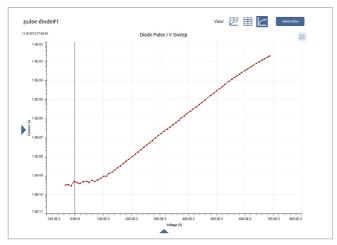
For some devices, multiple types of electrical measurements are required, such as pulsed I-V, DC I-V, and C-V tests. This usually requires an external switch matrix capable of switching the various types of signals to the device under test. However, the optional 4225-RPM Remote Preamplifier/Switch Module allows for switching automati cally between DC I-V, C-V, and pulsed I-V measurements, greatly simplfying the connections to the device.



4225-RPM Remote Preamplifier/Switch Module.

Users can perform all the electrical measurements on the device without having to disconnect and reconnect cabling for each test, which ultimately saves valuable test time and reduces frustration.

The 4225-RPM also serves as a preamp to extend the lower current ranges on the PMU. This is especially important for devices, such as diodes, that have I-V characteristics that extend over several decades of current. The pulsed I-V measurements of the diode through the 4225-RPM Remote Preamplifier/Switch are shown below. Its unique auto-range feature enables automatic range selection while the pulsed I-V sweep is in progress, so the user isn't forced to select a fixed range, which can reduce measurement resolution.



4225-RPM provides lower current ranges for pulse applications.

The optional Multi-measurement Prober Cable Kits (4210-MMPC) connect the 4200A-SCS Parameter Analyzer to a prober manipulator. In addition to eliminating the need for re-cabling, these kits help maximize signal fidelity by eliminating the measurement errors that often result from cabling errors.

#### **Switch Matrices**

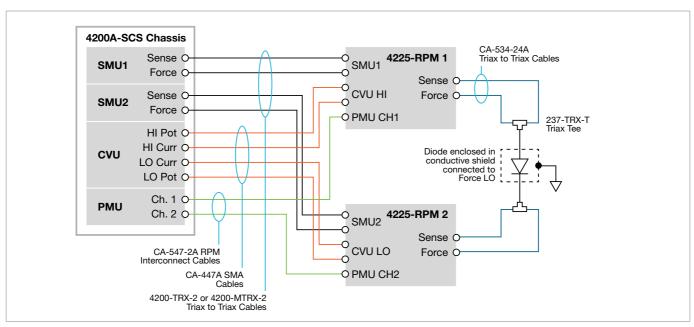
A number of switch matrix configurations are available for the 4200A-SCS.

The six-slot 707B and single-slot 708B Semiconductor Switch Matrix mainframes slash the time from command to connection, offering significantly faster test sequences and overall system throughput than earlier mainframe designs.



708B and 707B Switch Matrix mainframes.

They are specifically designed for the requirements of both semiconductor lab and production test environments, delivering ultra-low current switching performance using standard triaxial connectors and cables.



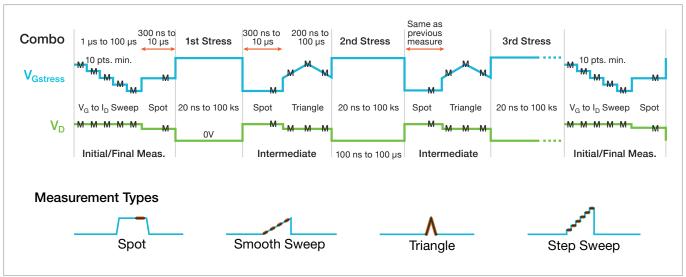
Connection diagram when using 4225-RPM Remote Preamplifer/Switch Module.

## 6. NBTI/PBTI Package

Modeling negative/positive bias temperature instability (NBTI/PBTI) is a challenge when developing deeply scaled silicon CMOS transistor designs. Over time, NBTI effects cause a transistor's threshold voltage (V<sub>T</sub>) to shift and its sub-threshold drain current to increase significantly, severely limiting transistor lifetime and circuit performance. These effects must be accurately modeled during device development and monitored during process integration and production. During BTI characterization, the transistor is alternately stressed and characterized. However, the BTI mechanism is susceptible to relaxation effects. which means that the instant the stress is removed, the transistor starts to recover and the degradation fades. Characterizing the degradation prior to relaxation demands the use of ultra-fast I-V techniques.

The 4200A-SCS offers the industry's most advanced NBTI/PBTI test platform for making sophisticated measurements on leading edge silicon CMOS technology. BTI testing requires a 4225-PMU Ultra Fast I-V Module, two 4225-RPM Remote Preamplifier/Switches, and Keithley's Automated Characterization Suite (ACS) software. The ACS software includes a built in Ultra-Fast BTI Test Project Module.

The Ultra-Fast BTI test software module supports spot, step sweep, smooth sweep, and sample measurement types. Each type's timing is defined by the test sample rate and the individual measurement settings. The software module also provides control over the voltage conditions between each element in the test sequence. for maximum flexibility and ease of use, even when defining complex test sequences.



Ultra-fast BTI package supports spot, smooth sweep, triangle, and step sweep measurement types.

# **Specifications**

All specifications are guaranteed unless noted otherwise. All specifications apply to all models unless noted otherwise.

## 1. Source Measure Units

|                  | 4200-SMU and 4201-SMU<br>Medium Power | 4210-SMU and 4211-SMU<br>High Power | Optional 4200-PA<br>Remote Preamplifier       |
|------------------|---------------------------------------|-------------------------------------|---|
| Current, maximum | 100 mA                                | 1 A                                 |   |
| Voltage, maximum | 210 V                                 | 210 V                               | Extends low current measure range of all SMUs |
| Power            | 2.1 W                                 | 21 W                                | range or an omeo                              |

| <b>General Information</b> |  |
|----------------------------|--|
|                            | Four-quadrant source/sink operation  |
|                            | A/D converter on every SMU   |
|                            | Full remote sense capability   |
|                            | Linear, log, list, and segment measurement sweeps  |
|                            | 4200A-SCS mainframe can accept up to nine medium or high power SMU instruments   |
| Output Connectors          | Three mini-triaxial (f) on each SMU for Force, Sense and Sense Lo<br>One custom, 15-pin, D-Sub (f) for connection to 4200-PA                           |
| Optional Accessory         | 4200-PA remote preamplifier module   |
| Equivalent Instruments     | Field installable SMUs (4200-SMU-R, 4201-SMU-R, 4210-SMU-R, and 4211-SMU-R) have equivalent specifications to their non-field installable counterparts |

## **SMU Current Specifications** <sup>4</sup>

|                     |  |                    |                 | N                       | Measure                     |                         | Source                      |
|---------------------|--|--------------------|-----------------|-------------------------|-----------------------------|-------------------------|-----------------------------|
|                     |  | Current<br>Range 1 | Max.<br>Voltage | Resolution <sup>3</sup> | Accuracy<br>±(% rdg + amps) | Resolution <sup>3</sup> | Accuracy<br>±(% rdg + amps) |
|                     |  | 1 A                | 21 V            | 1 μΑ                    | 0.100% + 200 μA             | 50 μA                   | 0.100% + 350 μA             |
|                     |  | 100 mA             | 210 V           | 100 nA                  | 0.045% + 3 μA               | 5 μΑ                    | 0.050% + 15 μA              |
| 4210-SMU            |  | 100 mA             | 21 V            | 100 nA                  | 0.045% + 3 μA               | 5 μΑ                    | 0.050% + 15 μA              |
| High Power          | 4200-SMU<br>Medium   | 10 mA              | 210 V           | 10 nA                   | 0.037% + 300 nA             | 500 nA                  | 0.042% + 1.5 μA             |
| SMU and<br>4211-SMU | Power SMU  | 1 mA               | 210 V           | 1 nA                    | 0.035% + 30 nA              | 50 nA                   | 0.040% + 150 nA             |
| High Power          | and<br>4201-SMU<br>Medium<br>Power SMU <sup>2</sup>  | 100 μΑ             | 210 V           | 100 pA                  | 0.033% + 3 nA               | 5 nA                    | 0.038% + 15 nA              |
| SMU <sup>2</sup>    |  | 10 μΑ              | 210 V           | 10 pA                   | 0.050% + 600 pA             | 500 pA                  | 0.060% + 1.5 nA             |
|                     |  | 1 μΑ               | 210 V           | 1 pA                    | 0.050% + 100 pA             | 50 pA                   | 0.060% + 200 pA             |
|                     |  | 100 nA             | 210 V           | 100 fA                  | 0.050% + 30 pA              | 5 pA                    | 0.060% + 30 pA              |
|                     |  | 10 nA              | 210 V           | 10 fA                   | 0.050% + 1 pA               | 500 fA                  | 0.060% + 3 pA               |
|                     |  | 1 nA               | 210 V           | 1 fA                    | 0.050% + 100 fA             | 50 fA                   | 0.060% + 300 fA             |
|                     | 42XX-SMU with optional<br>4200-PA Preamp   |                    | 210 V           | 300 aA                  | 0.100% + 30 fA              | 15 fA                   | 0.100% + 80 fA              |
|                     |  |                    | 210 V           | 100 aA                  | 0.500% + 15 fA              | 5 fA                    | 0.500% + 50 fA              |
|                     |  | 1 pA               | 210 V           | 10 aA                   | 1.000% + 10 fA              | 1.5 fA                  | 1.000% + 40 fA              |
| Voltage Compl       | Voltage Compliance: Bipolar limits set with a single value between full scale and 10% of selected voltage range. |                    |                 |                         |                             |                         |                             |

- 1. All ranges extend to 105% of full scale.
- 2. Specifications apply on these ranges with or without a 4200-PA.
- 3. Display resolution is limited by fundamental noise limits. Measured resolution is 6½ digits on each range. Source resolution is 4½ digits on each range.
- 4. The measurement and source accuracy are specified at the termination of the supplied cables.
   23°C ±5°C, within 1 year of calibration, RH between 5% and 60%, after 30 minutes of warmup.
   Speed set to NORMAL.

  - Guarded Kelvin connection.
  - ±1°C and 24 hours from ACAL.

## **SMU Voltage Specifications** <sup>3</sup>

| Voltage Range 1  | Max. Current             |                          | e Range <sup>1</sup> Max. Current Measure |                              | S                       | Source                       |
|--|--------------------------|--------------------------|---|------------------------------|-------------------------|------------------------------|
|  | 4200-SMU and<br>4201-SMU | 4210-SMU and<br>4211-SMU | Resolution <sup>2</sup>                   | Accuracy<br>±(% rdg + volts) | Resolution <sup>2</sup> | Accuracy<br>±(% rdg + volts) |
| 200 V  | 10.5 mA                  | 105 mA                   | 200 μV                                    | 0.015% + 3 mV                | 5 mV                    | 0.02% + 15 mV                |
| 20 V   | 105 mA                   | 1.05 A                   | 20 μV                                     | 0.01% + 1 mV                 | 500 μV                  | 0.02% + 1.5 mV               |
| 2 V  | 105 mA                   | 1.05 A                   | 2 μV                                      | 0.012% + 150 μV              | 50 μV                   | 0.02% + 300 μV               |
| 200 mV   | 105 mA                   | 1.05 A                   | 0.2 μV                                    | 0.012% + 100 μV              | 5 μV                    | 0.02% + 150 μV               |
| Current Compliance: Bipolar limits set with a single value between full scale and 10% of selected current range. |                          |                          |   |                              |                         |                              |

- 1. All ranges extend to 105% of full scale.
- 2. Specifications apply on these ranges with or without a 4200-PA.
- 3. The measurement and source accuracy are specified at the termination of the supplied cables.
  - 23°C ±5°C, within 1 year of calibration, RH between 5% and 60%, after 30 minutes of warmup.
  - Speed set to NORMAL.
  - Guarded Kelvin connection.

## **SMU Maximum Capacitance Specifications**

|                                       | Current Range      | Maximum Load<br>Capacitance between<br>Force HI and Force LO<br>terminals | Maximum Guard<br>Capacitance between<br>Force HI and Guard<br>terminals | Maximum Shield<br>Capacitance between<br>Guard and Force LO<br>terminals |  |
|---------------------------------------|--------------------|---|---|--|--|
| 4211-SMU                              | 1 A                | 100 μF  |   |  |  |
| 4201-SMU or 4211-SMU                  | 100 mA             | 100 μF  |   |  |  |
| 4201-SMU or 4211-SMU                  | 100 nA to 10 mA    | 10 μF   | 5 nF  | 10 nF  |  |
| 4201-SMU or                           | 1 nA to 10 nA      | 10 μF   |   |  |  |
| 4211-SMU with<br>4200-PA preamplifier | 1 pA to 100 pA     | 1 μF  |   |  |  |
| 4200-SMU, 4210-SMU                    | All current ranges | 10 nF   | 1500 pF   | 3300 pF  |  |

## **Voltage Monitor Mode**

High impedence voltmeter mode set at 0 Amps.

#### Accuracy & Resolution

| Voltage Range | Measure Resolution | Measure Accuracy<br>±(%rdg + volts) |
|---------------|--------------------|-------------------------------------|
| 200 V         | 200 μV             | 0.015% + 3 mV                       |
| 20 V          | 20 μV              | 0.01% + 1 mV                        |
| 2 V           | 2 μV               | 0.012% + 110 μV                     |
| 200 mV        | 0.2 μV             | 0.012% + 80 μV                      |

| Input Impedance              | >10 <sup>13</sup> Ω  |
|------------------------------|--|
| Input Leakage Current        | <30 pA   |
| Measurement Noise            | 0.02% of measure range (rms).  |
| Differential Voltage Monitor | Use two SMUs in VMU mode or use the low sense terminal provided with each SMU. |

## **SMU Supplemental Information**

Supplemental information is not warranted but provides useful information about the 4200-SMU, 4210-SMU Instruments.

| Compliance Accuracy    | Voltage compliance equals the voltage source specifications Current compliance equals the current source specifications |  |  |  |
|------------------------|---|--|--|--|
| Overshoot              | <0.1% typical   |  |  |  |
| Voltage                | Full scale step, resistive load, and 10 mA range  |  |  |  |
| Current                | 1 mA step, $R_L = 10 \text{ k}\Omega$ , 20 V range  |  |  |  |
| Range Change Transient |   |  |  |  |
| Voltage Ranging        | <200 mV   |  |  |  |
| Current Ranging        | <200 mV   |  |  |  |

## Temperature and Humidity Effect on Accuracy

Accuracy specifications are multiplied by one of the following factors, depending upon the ambient temperature and humidity.

|             | % Relative Humidity |       |  |
|-------------|---------------------|-------|--|
| Temperature | 5-60                | 60-80 |  |
| 10°-18°C    | ×3                  | ×3    |  |
| 18°-28°C    | ×1                  | ×3    |  |
| 28°-40°C    | ×3                  | ×5    |  |

| Remote Sense                    | <10 $\Omega$ in series with FORCE terminal not to exceed a 5 V difference between FORCE and SENSE terminals |
|---------------------------------|---|
|                                 | ±30 V maximum between COMMON and SENSE LO.  |
| Maximum Guard Offset Voltage    | 3 mV from FORCE   |
| Guard Output Impedance          | 100 kΩ  |
| 4200-SMU and 4210-SMU Shun      | t Resistance (Force to Common)<br>>10 <sup>12</sup> Ω (100 nA-1 μA ranges)                                  |
| 4200-PA Shunt Resistance (Force | ce to Common) >10 $^{16}$ $\Omega$ (1 pA and 10 pA ranges), >10 $^{13}$ $\Omega$ (100 pA–100 nA ranges)     |
| Noise Characteristics (typical) |   |
| Voltage Source (rms)            | 0.01% of output range   |
| Current Source (rms)            | 0.1% of output range  |
| Voltage Measure (p-p)           | 0.02% of measurement range  |
| Current Measure (p-p)           | 0.2% of measurement range   |
| Maximum Slew Rate               | 0.2 V/μs  |
| DC Floating Voltage             | Common can be floated ±32 V from chassis ground   |

## 2. SMU Preamplifier Module

The low current measurement capabilities of any SMU can be extended by adding an optional 4200-PA preamplifier. The preamplifier provides 10 aA resolution by effectively adding five current ranges to either SMU model. The preamp module is fully integrated with the system; to the user, the SMU simply appears to have additional measurement resolution available.

## 4200-PA General information

| Installation      |  |
|-------------------|--|
| Local             | The preamplifier is shipped installed on the back panel of the 4200A-SCS for local operation.  |
| Remote            | Users can remove the preamplifier from the back panel and place it in a remote location (such as in a light-tight enclosure or on the prober platen) to eliminate measurement problems due to long cables. |
| Input Connectors  | One custom, 15 pin, D-Sub (m)  |
| Output Connectors | Two triaxial (f)   |
| Dimensions        | 0.79 in. wide $\times$ 4.4 in. deep $\times$ 2.2 in. tall (2 cm wide $\times$ 11.3 cm deep $\times$ 5.6 cm tall)   |
| Weight            | 4.8 oz. (136 g)  |

## SMU Current Specifications with 4200-PA Preamplifier 4

|                                |  |                               |                 | Measure                 |                             |                         | Source                      |
|--------------------------------|--|-------------------------------|-----------------|-------------------------|-----------------------------|-------------------------|-----------------------------|
|                                |  | Current<br>Range <sup>1</sup> | Max.<br>Voltage | Resolution <sup>3</sup> | Accuracy<br>±(% rdg + amps) | Resolution <sup>3</sup> | Accuracy<br>±(% rdg + amps) |
|                                |  | 1 A                           | 21 V            | 1 μΑ                    | 0.100% + 200 μA             | 50 μA                   | 0.100% + 350 μΑ             |
| 4040 00411                     |  | 100 mA                        | 210 V           | 100 nA                  | 0.045% + 3 μA               | 5 μΑ                    | 0.050% + 15 μA              |
| 4210-SMU<br>High Power         |  | 100 mA                        | 21 V            | 100 nA                  | 0.045% + 3 μA               | 5 μΑ                    | 0.050% + 15 μA              |
| SMU                            | 4200-SMU<br>Medium                       | 10 mA                         | 210 V           | 10 nA                   | 0.037% + 300 nA             | 500 nA                  | 0.042% + 1.5 μA             |
| and                            | Power SMU                                | 1 mA                          | 210 V           | 1 nA                    | 0.035% + 30 nA              | 50 nA                   | 0.040% + 150 nA             |
| 4211-SMU                       | and                                      | 100 μΑ                        | 210 V           | 100 pA                  | 0.033% + 3 nA               | 5 nA                    | 0.038% + 15 nA              |
| High Power<br>SMU <sup>2</sup> | 4201-SMU                                 | 10 μΑ                         | 210 V           | 10 pA                   | 0.050% + 600 pA             | 500 pA                  | 0.060% + 1.5 nA             |
|                                | Medium<br>Power SMU <sup>2</sup>         | 1 μΑ                          | 210 V           | 1 pA                    | 0.050% + 100 pA             | 50 pA                   | 0.060% + 200 pA             |
|                                | 1 GWCI GIVIG                             | 100 nA                        | 210 V           | 100 fA                  | 0.050% + 30 pA              | 5 pA                    | 0.060% + 30 pA              |
|                                |  | 10 nA                         | 210 V           | 10 fA                   | 0.050% + 1 pA               | 500 fA                  | 0.060% + 3 pA               |
|                                |  | 1 nA                          | 210 V           | 1 fA                    | 0.050% + 100 fA             | 50 fA                   | 0.060% + 300 fA             |
|                                | 42XX-SMU with optional<br>4200-PA Preamp |                               | 210 V           | 300 aA                  | 0.100% + 30 fA              | 15 fA                   | 0.100% + 80 fA              |
| 7200-1 A 1 Teamp               |  | 10 pA                         | 210 V           | 100 aA                  | 0.500% + 15 fA              | 5 fA                    | 0.500% + 50 fA              |
|                                |  | 1 pA                          | 210 V           | 10 aA                   | 1.000% + 10 fA              | 1.5 fA                  | 1.000% + 40 fA              |
| Voltage Compl                  | liance: Bipolar lin                      | nits set with a               | single value be | tween full scale a      | and 10% of selected volta   | age range.              |                             |

- 1. All ranges extend to 105% of full scale.
- 2. Specifications apply on these ranges with or without a 4200-PA.
- 3. Display resolution is limited by fundamental noise limits. Measured resolution is 6½ digits on each range. Source resolution is 4½ digits on each range.
- 4. The measurement and source accuracy are specified at the termination of the supplied cables.
  - 23°C ±5°C, within 1 year of calibration, RH between 5% and 60%, after 30 minutes of warmup.
  - Speed set to NORMAL.
  - Guarded Kelvin connection.

# 3. Multi-Frequency Capacitance-Voltage Units

|                              | 4210-CVU  | 4215-CVU  |
|------------------------------|---|---|
| General Information          |   |   |
| Measurement configuration    | Four-terminal pair, High POT, High CUR, Low POT, Low CUR                      | Four-terminal pair, High POT, High CUR,<br>Low POT, Low CUR                   |
| Output connectors            | Four SMA (f)  | Four SMA (f)  |
| Supplied cable               | 100 Ω, SMA (m) to SMA (m), 1.5 m, 4 each                                      | 100 Ω, SMA (m) to SMA (m), 1.5 m, 4 each                                      |
| Optional cables              | 100 Ω, SMA (m) to SMA (m), 3 m  | 100 Ω, SMA (m) to SMA (m), 3 m  |
| Measurement Functions        |   |   |
| Measurement parameters       | $C_P$ -G, $C_P$ -D, $C_S$ -R <sub>S</sub> , $C_S$ -D, R-jX, Z-theta , Y-theta | $C_P$ -G, $C_P$ -D, $C_S$ -R <sub>S</sub> , $C_S$ -D, R-jX, Z-theta , Y-theta |
| Ranging                      | Auto and fixed  | Auto and fixed  |
| Integration time             | Fast, Normal, Quiet, and Custom   | Fast, Normal, Quiet, and Custom   |
| Test Signal                  |   |   |
| Frequency range              | 1 kHz to 10 MHz   | 1 kHz to 10 MHz   |
| Minimum resolution           | 1 kHz, 10 kHz, 100 kHz, 1 MHz depending on frequency range                    | 1 kHz for entire range  |
| Source frequency accuracy    | ±0.1%   | ±0.1%   |
| Signal output level range    | 10 mV rms to 100 mV rms   | 10 mV to 1 V rms  |
| Resolution                   | 1 mV rms  | 1 mV rms  |
| Accuracy                     | ±(10.0% + 1 mV rms) unloaded (at rear panel)                                  | ±(10.0% + 1 mV rms) unloaded (at rear panel)                                  |
| Output impedance             | 100 Ω, typical  | 100 Ω, typical  |
| DC Bias Function             |   |   |
| DC voltage bias range        | ±30 V (60 V differential)   | ±30 V (60 V differential)   |
| DC voltage bias resolution   | 1.0 mV  | 1.0 mV  |
| DC voltage bias accuracy     | ±(0.5% + 5.0 mV) unloaded   | ±(0.5% + 5.0 mV) unloaded   |
| Maximum DC current           | 10 mA   | 10 mA   |
| Sweep Characteristics        |   |   |
| Available sweep parameters   | DC bias voltage, frequency, AC voltage  | DC bias voltage, frequency, AC voltage  |
| Sweep type                   | Linear, custom  | Linear, log, custom   |
| Sweep direction              | Up sweep, down sweep  | Up sweep, down sweep  |
| Number of measurement points | 4096  | 4096  |

## Measurement Accuracy 4,5

#### Example of C/G Measurement Accuracy

| Frequency           | Measured Capacitance | C Accuracy 1 | G Accuracy 1, 2, 6                     |
|---------------------|----------------------|--------------|--|
|                     | 1 pF                 | ±0.92%       | 4210-CVU: ±600 nS<br>4215-CVU: ±1.7 µS |
| 10 MHz <sup>3</sup> | 10 pF                | ±0.32%       | ±3.9 µS                                |
| İ                   | 100 pF               | ±0.29%       | ±17 μS                                 |
|                     | 1 nF                 | ±0.35%       | ±176 µS                                |
| İ                   | 1 pF                 | ±1.17%       | ±64 nS                                 |
| 1 MHz               | 10 pF                | ±0.19%       | ±65 nS                                 |
| I IVII IZ           | 100 pF               | ±0.10%       | ±610 nS                                |
| ı                   | 1 nF                 | ±0.09%       | ±4 μS                                  |
| İ                   | 10 pF                | ±0.31%       | ±28 nS                                 |
| 100 kHz             | 100 pF               | ±0.18%       | ±59 nS                                 |
| 100 KHZ             | 1 nF                 | ±0.10%       | ±450 nS                                |
| i                   | 10 nF                | ±0.10%       | ±3 μS                                  |
| ı                   | 100 pF               | ±0.31%       | ±15 nS                                 |
| 10 kHz              | 1 nF                 | ±0.15%       | ±66 nS                                 |
| IU KI IZ            | 10 nF                | ±0.08%       | ±450 nS                                |
| İ                   | 100 nF               | ±0.10%       | ±3 μS                                  |
|                     | 1 nF                 | ±0.82%       | ±40 nS                                 |
| 1 kHz               | 10 nF                | ±0.40%       | ±120 nS                                |
| I NIIZ              | 100 nF               | ±0.10%       | ±500 nS                                |
|                     | 1 μF                 | ±0.15%       | ±10 μS                                 |

#### Notes

- 1. The capacitance and conductance measurement accuracy is specified under the following conditions:  $D_X < 0.1$ .
- 2. Conductance accuracy is specified as the maximum conductance measured on the referenced capacitor.
- 3. Specifications at 10 MHz are typical, non-warranted, apply at 23 °C, and are provided solely as useful information.
- 4. Integration time: 1 s or 10 s below 10 kHz. Test signal level: 30 mV rms. At the rear panel of the 4210-CVU or 4215-CVU. All specifications apply at 23  $^{\circ}$ C  $\pm 5^{\circ}$ C, within one year of calibration, RH between 5% and 60%, after 30 minutes of warmup. 5. Above specifications also apply for the 4215-CVU at 300 mV.
- 6. G Accuracy is a typical, non-warranted specification provided for reference.

## CVU Supplemental Cable Specification 3,4

The following specifications are examples of typical accuracy when taking measurements though cables. They are standalone specifications and therefore are provided separately from the specifications above which represent the guaranteed accuracy at the rear terminals of the CVU. These specifications are typical, non-warranted, apply at 23°C, and are provided solely as useful information.

#### 4210-CVU and 4215-CVU Typical C Accuracy1 with 1.5m Cables (supplemental)

| Measured Capacitance | 1 kHz  | 10 kHz | 100 kHz | 1 MHz  | 10 MHz |
|----------------------|--------|--------|---------|--------|--------|
| 1 pF                 | N/A    | ±8.38% | ±1.95%  | ±0.43% | N/A    |
| 10 pF                | N/A    | ±0.94% | ±0.21%  | ±0.18% | N/A    |
| 100 pF               | N/A    | ±0.29% | ±0.20%  | ±0.15% | ±1%    |
| 1 nF                 | ±0.72% | ±0.17% | ±0.12%  | ±0.16% | ±2%    |
| 10 nF                | ±0.28% | ±0.12% | ±0.13%  | ±0.55% | N/A    |
| 100 nF               | ±0.12% | ±0.13% | ±0.22%  | ±1.14% | N/A    |
| 1 μF                 | ±0.17% | ±0.21% | N/A     | N/A    | N/A    |

#### 4210-CVU and 4215-CVU Typical C Accuracy1 with 3m Cables (supplemental)

| Measured Capacitance | 1 kHz  | 10 kHz | 100 kHz | 1 MHz  | 10 MHz |
|----------------------|--------|--------|---------|--------|--------|
| 1 pF                 | N/A    | ±8.5 % | ±2.05%  | ±0.57% | N/A    |
| 10 pF                | N/A    | ±0.96% | ±0.23%  | ±0.21% | N/A    |
| 100 pF               | N/A    | ±0.29% | ±0.20%  | ±0.17% | N/A    |
| 1 nF                 | ±0.72% | ±0.17% | ±0.12%  | ±0.18% | N/A    |
| 10 nF                | ±0.28% | ±0.12% | ±0.13%  | ±0.65% | N/A    |
| 100 nF               | ±0.12% | ±0.13% | ±0.22%  | ±1.16% | N/A    |
| 1 μF                 | ±0.17% | ±0.21% | N/A     | N/A    | N/A    |

- 1. The capacitance and conductance measurement accuracy is specified under the following conditions:  $D_x < 0.1$ .
- 2. These specs are typical, non-warranted, apply at 23°C, and are provided solely as useful information.
- 3. Integration time: 1 s or 10 s below 10 kHz. Test signal level: 30 mV rms.
- 4. Above specifications also apply for the 4215-CVU at 300 mV.

## 4. CV-IV Multi-Switch Module

The C-V/I-V Multi-Switch automatically switches between I-V and C-V measurements. In addition, C-V measurements can be moved to any output channel without recabling. Each channel is user configurable for low current measurement capabilities using the 4200-PA preamplifier or standard current resolution with a SMU Pass Thru 4200A-CVIV-SPT.

#### 4200A-CVIV General Information

4200-PA Preamplifier: Custom, 15-pin, D-Sub (m) Input connectors 4200-CVIV-SPT SMU Pass-thru Module: Two triaxial (f) per module CVU: Four SMA (f)

CVIV Ground Unit: Mini-triaxial

19.8 cm wide  $\times$  14.2 cm high  $\times$  11.1 cm deep **Dimensions** (7.8 in. wide  $\times$  5.6 in. tall  $\times$  4.4 in. deep)

Eight triaxial (f)

Weight 1.5 kg (3.3 lb)

From 4200A-SCS mainframe via USB cable Power

Output channels Configurable up to 4 channels

210 V Voltage, max.

1 A SMU Path With 4200-PA With 4200A-CVIV-SPT

Offset current <100 fA <1 pA Offset voltage <100 µV <100 µV Shunt resistance >1e15 Ω >1e14 Ω DC output resistance (2-wire) 1.5 Ω 1.5 Ω DC output resistance (4-wire) <100 mΩ  $<100~\text{m}\Omega$ 

CVU Path

Current, max.

**Output connectors** 

AC output impedance 100  $\Omega$ , typical (center pin to outer shield)

Accuracy, typical Refer to chart below

#### CVU DC Bias Function, using CVU Instrument

DC biasing of AC signals is provided by the 4210-CVU or 4215-CVU instrument models. See next section for biasing with SMUs.

Range ±30V at 10 mA max. (60 V differential)

Resolution 1 mV Additional errors (for CVU bias) <50 µV DC output resistance (4 wire)  $<100~m\Omega$ 

#### Typical Accuracy of 4210-CVU and 4215-CVU through the 4200A-CVIV Multi-Switch, 2-wire mode unless otherwise noted 1,3

| Measured Capacitance | 1 kHz         | 10 kHz | 100 kHz       | 1 MHz               |
|----------------------|---------------|--------|---------------|---------------------|
| 1 pF                 | Not Specified | ±9.0%  | ±2.2%         | ±0.7%               |
| 10 pF                | Not Specified | ±1.0%  | ±0.5%         | ±0.5%               |
| 100 pF               | Not Specified | ±0.5%  | ±0.5%         | ±0.5%               |
| 1 nF                 | ±0.8%         | ±0.5%  | ±0.5%         | ±0.5% <sup>2</sup>  |
| 10 nF                | ±0.5%         | ±0.5%  | ±0.5%         | ±0.75% <sup>2</sup> |
| 100 nF               | ±0.5%         | ±0.5%  | ±0.5%         | ±1.25% <sup>2</sup> |
| 1 μF                 | ±0.5%         | ±0.5%  | Not Specified | Not Specified       |

- 1. Valid when CVU compensation is applied from a <1 month old compensation acquisition.
- 2. Specified in 4-wire mode: 4-wire always recommended for low impedance devices
- 3. The specifications above are typical, non-warranted, apply at 25°C, and are provided solely as useful information.

#### CVU DC Bias Function, using SMU Instrument in bias tee

DC biasing of AC signals is provided by the 42XX-SMU instrument modules.

Range BiasT CV LO I Mode: ±210 V (420 V differential) and 1 mA maximum.

BiasT CV Mode: ±210 V (420 V differential) and 1 A maximum.

#### Typical Accuracy of 4210-CVU and 4215-CVU through the 4200A-CVIV Multi-Switch, 2-terminal bias tee

| Measured Capacitance | 1 kHz         | 10 kHz        | 100 kHz       | 1 MHz         |
|----------------------|---------------|---------------|---------------|---------------|
| 1 pF                 | Not Specified | Not Specified | ±2.4%         | ±0.7%         |
| 10 pF                | Not Specified | ±2.9%         | ±0.5%         | ±0.5%         |
| 100 pF               | Not Specified | ±0.5%         | ±0.5%         | ±0.5%         |
| 1 nF                 | ±1.9%         | ±0.5%         | ±0.5%         | ±0.5%         |
| 10 nF                | ±0.7%         | ±0.5%         | ±0.5%         | ±0.75%        |
| 100 nF               | ±0.7%         | ±0.5%         | ±0.5%         | ±2.3%         |
| 1 μF                 | ±3.5%         | ±2.0%         | Not Specified | Not Specified |

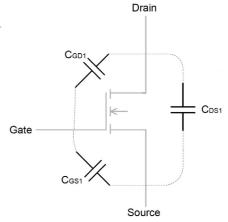
#### Notes

- These specs are typical, non-warranted, apply at 23 °C, and are provided solely as useful information.
- Measurements verified using 4210-CVU and 4215-CVU in 2 wire and Bias Tee Low I modes.
- Specification is valid up to 1 mA. Accuracy of measurements taken while sourcing above 1 mA is not specified.
- Measurement speed: Quiet, Test signal level: 30 mV rms, AC Measure I Range: Auto.
- Valid when CVU CVIV compensation is applied from a <1 month old compensation acquisition.

#### Typical Accuracy of 4210-CVU and 4215-CVU through the 4200A-CVIV Multi-Switch, 3-terminal bias tee

| Measured Capacitance | 1 kHz         | 10 kHz | 100 kHz | 1 MHz         |
|----------------------|---------------|--------|---------|---------------|
| Cgd = 100 pF         | Not Specified | ±5.0%  | ±5.0%   | Not Specified |
| Cds = 1 nF           | ±10.0%        | ±2.0%  | ±2.0%   | ±30.0%        |
| Cgs = 10 nF          | ±3.0%         | ±2.0%  | ±2.0%   | ±3.0%         |
| Measured Capacitance | 1 kHz         | 10 kHz | 100 kHz | 1 MHz         |
| Cgd = 100 pF         | Not Specified | ±2.0%  | ±2.0%   | ±5.0%         |
| Cds = 420 pF         | ±20.0%        | ±2.0%  | ±2.0%   | ±5.0%         |
| Cgs = 1 nF           | ±6.0%         | ±2.0%  | ±2.0%   | ±3.0%         |

- $\bullet~$  These specs are typical, non-warranted, apply at 23 °C, and are provided solely as useful information.
- Measurements verified using 4210-CVU and 4215-CVU and the following CVIV configuration:
  - Ch1: BiasT: SMU LO I CV HI
  - Ch2: BiasT: SMU LO I CV LO
  - Ch3: Ground Unit
  - Ch4: Open
  - 2-Wire Mode
- Measurement speed: Quiet, Test signal level: 30 mV rms, AC Measure I Range: Auto
- Valid when CVU CVIV compensation is applied from a <1 month old compensation acquisition.



## 5. Ultra-fast Pulse Measure Unit

The two-channel 4225-PMU provides the combination of ultra-fast voltage waveform generation with fast simultaneous voltage and current measurements.

| 4225-PMU General Information |  |  |  |  |
|------------------------------|--|--|--|--|
| Output connectors            | Four SMA (f) and two HDMI  |  |  |  |
| Suppled cables               | SMA (m) to SMA (m), 2 m, 4 each (CA-404B)<br>SMA to SSMC Y-cable, 15 cm (6 in.), 2 each (4200-PRB-C) |  |  |  |
| Optional accessory           | 4225-RPM single-channel, remote preamplifier/switch module   |  |  |  |

#### **PMU Current Measurement**

Timing parameters, typical 1 with or without the 4225-RPM Remote Preamplifier/Switch Module

|  | 10 V F | 40 V Range |        |
|--|--------|------------|--------|
| Current measure ranges                           | 10 mA  | 200 mA     | 800 mA |
| Recommended minimum pulse width <sup>2</sup>     | 160 ns | 70 ns      | 770 ns |
| Recommended minimum measure window <sup>2</sup>  | 20 ns  | 20 ns      | 100 ns |
| Recommended minimum transition time <sup>3</sup> | 20 ns  | 20 ns      | 100 ns |
| Noise 4  | 15 μΑ  | 50 μΑ      | 200 μΑ |
| Settling time 5                                  | 100 ns | 30 ns      | 500 ns |

#### Notes

- 1. All typical values measured with an open circuit.
- 2. Using default measure window of 75% to 90% of pulse top. Recommended minimum pulse width = (Settling Time) / 75%.
- 3. Recommended rise/fall time to minimize overshoot.
- 4. RMS noise measured over the Recommended Minimum Measure Window for the given voltage or current range, typical.
- 5. Time necessary for the signal to settle to the DC accuracy level. (Example: 10 mA settling time on the PMU 10 V range is defined when the signal is within 1.25% of the final value. This calculation: Accuracy = 0.25% + 100 μA = 0.25% + (100 μA/10 mA) = 0.25% + 1% = 1.25%).
- 6. 10 mA noise specification is different if RPM is used. See table below

#### Timing parameters, typical 1 with the 4225-RPM Remote Preamplifier/Switch Module

|  | 10V Range |         |         |         | 40 V Range |                    |        |        |
|--|-----------|---------|---------|---------|------------|--------------------|--------|--------|
| Current measure ranges                           | 100 nA    | 1 μΑ    | 10 μΑ   | 100 μΑ  | 1 mA       | 10 mA <sup>6</sup> | 100 μΑ | 10 mA  |
| Recommended minimum pulse width <sup>2</sup>     | 134 µs    | 20.4 µs | 8.36 µs | 1.04 µs | 370 ns     | 160 ns             | 6.4 µs | 770 ns |
| Recommended minimum measure window <sup>2</sup>  | 10 µs     | 1.64 µs | 1 µs    | 130 ns  | 40 ns      | 20 ns              | 1 µs   | 100 ns |
| Recommended minimum transition time <sup>3</sup> | 1 µs      | 360 ns  | 360 ns  | 40 ns   | 30 ns      | 20 ns              | 1 μs   | 100 ns |
| Noise 4  | 200 pA    | 2 nA    | 5 nA    | 50 nA   | 300 nA     | 1.5 µA             | 75 nA  | 5 μΑ   |
| Settling time 5                                  | 100 µs    | 15 µs   | 6 µs    | 750 ns  | 250 ns     | 100 ns             | 4 µs   | 500 ns |

- 1. All typical values measured with an open circuit.
- $2. \ \ Using default measure window of 75\% to 90\% of pulse top. Recommended minimum pulse width = (Settling Time) / 75\%.$
- 3. Recommended rise/fall time to minimize overshoot.
- 4. RMS noise measured over the Recommended Minimum Measure Window for the given voltage or current range, typical.
- 5. Time necessary for the signal to settle to the DC accuracy level. (Example: 10 mA settling time on the PMU 10 V range is defined when the signal is within 1.25% of the final value. This calculation: Accuracy = 0.25% + 100 μA = 0.25% + (100 μA/10 mA) = 0.25% + 1% = 1.25%).
- 6. 10 mA noise specification is different without RPM. See table above.

## **PMU Voltage Sourcing and Current Measurement Accuracy**

|     |            | Voltage<br>Range    | Current<br>Range    | Current<br>Measurement<br>Accuracy | Voltage Sourcing<br>Accuracy |
|-----|------------|---------------------|---------------------|------------------------------------|------------------------------|
|     |            |                     | 800 mA              | ±(0.25% + 3 mA)                    |                              |
|     |            | 40 V                | 10 mA               | ±(0.5% + 100 μA)                   | ±(0.25% + 40 mV)             |
|     | 4225-PMU   |                     | 100 μΑ              | ±(0.25% + 1 μA)                    |                              |
|     |            | 10 V                | 200 mA              | ±(0.25% + 250 μA)                  | ±(0.25% + 10mV)              |
|     | 10 V       | 10 mA <sup>1</sup>  | ±(0.25% + 100 μA) 1 | ±(0.25% + 10111V)                  |                              |
|     |            |                     | 10 mA               | ±(0.5% + 10 μA)                    |                              |
|     |            |                     | 1 mA                | ±(0.5%+1 μA                        |                              |
|     | 1225-PMU   | 10 V                | 100 μΑ              | ±(0.5% + 100 nA)                   | ±(0.25% + 10 mV)             |
| wit | h 4225-RPM | ‡225-RPM 10 V 10 μ/ | 10 μΑ               | ±(0.5% + 30 nA)                    | ±(0.25% + 10111V)            |
|     |            |                     | 1 μΑ                | ±(0.5% + 1 nA)                     |                              |
|     |            |                     | 100 nA              | ±(0.5% + 1 nA)                     |                              |

#### Notes

## **PMU Voltage Measurement**

Timing parameters, typical 1

|   | 4225-PMU |        | 4225-RPM |
|---|----------|--------|----------|
| Voltage measure ranges                          | 10 V     | 40 V   | 10 V     |
| Recommended minimum pulse width <sup>2</sup>    | 70 ns    | 150 ns | 160 ns   |
| Recommended minimum measure window <sup>2</sup> | 20 ns    | 20 ns  | 20 ns    |
| Recommended minimum transition time 3           | 20 ns    | 100 ns | 20 ns    |
| Noise 4   | 2 mV     | 8 mV   | 1 mV     |
| Settling time 5                                 | 30 ns    | 30 ns  | 100 ns   |

- 1. All typical values measured with an open circuit.
- 2. Using default measure window of 75% to 90% of pulse top. Recommended minimum pulse width = (Settling Time) / 75%.
- 3. Recommended rise/fall time to minimize overshoot.
- 4. RMS noise measured over the Recommended Minimum Measure Window for the given voltage or current range, typical.
- 5. Time necessary for the signal to settle to the DC accuracy level. (Example: 10 mA settling time on the PMU 10 V range is defined when the signal is within 1.25% of the final value. This calculation: Accuracy =  $0.25\% + 100 \, \mu A = 0.25\% + (100 \, \mu A/10 \, mA) = 0.25\% + 1\% = 1.25\%$ ).

<sup>1.</sup> Accuracy for 10mA range is  $\pm$ (0.25% + 100uA) if no 4225-RPM attached and is  $\pm$ (0.5% + 10uA) with 4225-RPM attached.

## Voltage and Current, Maximum<sup>1</sup>

|                         | 10V F                  | Range                  | 40V F                  | Range                  |
|-------------------------|------------------------|------------------------|------------------------|------------------------|
| Resistance <sup>2</sup> | Maximum V <sup>2</sup> | Maximum I <sup>2</sup> | Maximum V <sup>2</sup> | Maximum I <sup>2</sup> |
| 1 Ω                     | 0.196 V                | 196 mA                 | 0.784 V                | 784 mA                 |
| 5 Ω                     | 0.909 V                | 182 mA                 | 3.64 V                 | 727 mA                 |
| 10 Ω                    | 1.67 V                 | 167 mA                 | 6.67 V                 | 667 mA                 |
| 25 Ω                    | 3.33 V                 | 133 mA                 | 13.3 V                 | 533 mA                 |
| 50 Ω                    | 5.00 V                 | 100 mA                 | 20.0 V                 | 400 mA                 |
| 100 Ω                   | 6.67 V                 | 66.7 mA                | 26.7 V                 | 267 mA                 |
| 250 Ω                   | 8.33 V                 | 33.3 mA                | 33.3 V                 | 133 mA                 |
| 1 kΩ                    | 9.52 V                 | 9.5 mA                 | 38.1 V                 | 38.1 mA                |
| 10 kΩ                   | 9.95 V                 | 995 μΑ                 | 39.8 V                 | 3.98 mA                |

#### Notes

1. To calculate the approximate maximum current and voltage for any resistance

 $I_{MAX} = V \text{ range/(50 } \Omega + \text{Resistance)}$ 

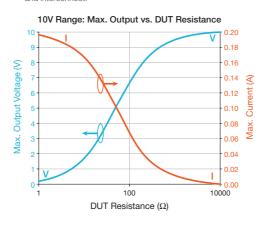
 $\mathbf{V}_{\text{MAX}} = \mathbf{I}_{\text{MAX}} \cdot \text{Resistance}$ 

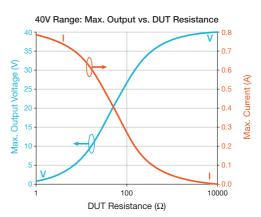
where Resistance is the total resistance connected to the PMU or PGU channel and V range is either 10 or 40.

Example: 10 V range using R = 10  $\Omega$  (for DUT + interconnect)

 $V_{MAX} = I_{MAX} \cdot R = 0.167 \cdot 10 = 1.67 \text{ V}$ 

Typical maximum at pulse output connector. Resistance is the total resistance connected to the pulse output connector, including device and interconnect.





## PMU Pulse/Level 1,2

|  |  | 10 V Range                 | 40 V Range                 |
|--|--|----------------------------|----------------------------|
| V  | 50 Ω into 1 MΩ                                   | –10 V to +10 V             | -40 V to +40 V             |
| V <sub>OUT</sub>                         | 50 Ω into 50 Ω                                   | −5 V to +5 V               | –20 V to +20 V             |
| Accuracy                                 |  | ±(0.5% + 10 mV)            | ±(0.2% + 20 mV)            |
| Resolution                               | 50 Ω into 50 Ω                                   | <250 μV                    | <750 μV                    |
| nesolution                               | 50 Ω into 1 MΩ                                   | <0.05 mV                   | <1.5 mV                    |
| Overshoot/pre-shoot/ringing <sup>3</sup> | 50 Ω into 50 Ω                                   | ±(3% + 20 mV)              | ±(3% + 80 mV)              |
|  | $50 \Omega$ into $50 \Omega$ , typical best case | ±(2% + 20 mV)              | ±(0.8% + 40 mV)            |
| Baseline noise                           |  | ±(0.3% + 1 mV) RMS typical | ±(0.1% + 5 mV) RMS typical |
| Source impedance                         |  | 50 Ω nominal               | 50 Ω nominal               |
| Current into 50Ω load (at full scale)    |  | ±100 mA typical            | ±400 mA typical            |
| Short circuit current                    |  | ±200 mA                    | ±800 mA                    |
| Output limit                             |  | Programmable limit to pro  | tect the device under test |

- 1. Unless stated otherwise, all specifications assume a 50  $\Omega$  termination.
- 2. Level specifications are valid after 50 ns typical settling time (after slewing) for the 10 V source range and after 500 ns typical settling time (after slewing) for the 40 V source range into a 50  $\Omega$  load.
- 3. With transition time of 20 ns (0%–100%) for the 10 V source range and 100 ns (0% to 100%) for the 40 V source range.

## **PMU Pulse Timing**

|  | 10 V Range<br>Source Only     | 10 V Range<br>with Measure    | 40 V Range<br>Source Only   | 40 V Range<br>with Measure    |
|--|-------------------------------|-------------------------------|-----------------------------|-------------------------------|
| Frequency range                        | 1 Hz to 50 MHz                | 1 Hz to 8.3 MHz               | 1 Hz to 10 MHz              | 1 Hz to 3.5 MHz               |
| Timing resolution                      | 10 ns                         | 10 ns                         | 10 ns                       | 10 ns                         |
| RMS jitter (period, width), typical    | 0.01% + 200 ps                | 0.01% + 200 ps                | 0.01% + 200 ps              | 0.01% + 200 ps                |
| Period range                           | 20 ns to 1 s                  | 120 ns to 1 s                 | 100 ns to 1s                | 280 ns to 1s                  |
| Accuracy                               | ±1%                           | ±1%                           | ±1%                         | ±1%                           |
| Pulse width range                      | 10 ns to (Period-10 ns)       | 60 ns to (Period-10 ns)       | 50 ns to (Period-10 ns)     | 140 ns to (Period-10 ns)      |
| Accuracy                               | ±(1% + 200 ps)                | ±(1% + 200 ps)                | ±(1% + 5 ns)                | ±(1% + 5 ns)                  |
| Programmable transition time (0%–100%) | 10 ns to 33 ms                | 20 ns to 33 ms                | 30 ns to 33 ms <sup>1</sup> | 100 ns to 33 ms               |
| Transition slew rate accuracy          | ±1%<br>(transitions > 100 ns) | ±1%<br>(transitions > 100 ns) | ±1%<br>(transitions > 1 µs) | ±1%<br>(transitions > 100 ns) |
| Solid state relay open/close time      | 25 µs                         | 25 µs                         | 25 µs                       | 25 µs                         |

#### Notes

## **Voltage Source, Best Performance**

When the 4225-PMU is used as a voltage source only (no measurements of voltage or current), the timing performance is improved. The following is provided to offer a clearer idea of best performance when used as a voltage source, as achievable under optimal conditions. This should not be interpreted as a guarantee.

|                            | 10V Range     | 40V Range                     |
|----------------------------|---------------|-------------------------------|
| Rise time                  | <10 ns        | 50 ns to 10 V, 100 ns to 40 V |
| Pulse width                | 10 ns (FWHM)  | 50 ns (FWHM)                  |
| Period                     | 20 ns         | 100 ns                        |
| Overshoot/preshoot/ringing | ±(2% + 20 mV) | ±(0.5% + 40 V)                |

<sup>1. 40</sup> V range minimum programmable transition time (source only) is 30 ns for voltage <10 V and 100 ns for voltages >10 V.

| Trigger                                     |         |
|---|---------|
| Trigger output impedance                    | 50 Ω    |
| Trigger output level                        | TTL     |
| Trigger in impedance                        | 10 kΩ   |
| Trigger in level                            | TTL     |
| Trigger in transition timing, maximum       | <100 ns |
| Trigger in to pulse output delay            | 400 ns  |
| Trigger synchronization/jitter <sup>1</sup> | <2 ns   |

#### **Segment ARB® and Timing**

Segment ARB capabilities are available with the 4225-PMU and 4220-PGU, with or without the 4225-RPM Remote Preamplifier/Switch Module.

| Max. Number of Segments <sup>2</sup>                         | 2048          |
|--|---------------|
| Max. Number of Sequences <sup>2</sup>                        | 512           |
| Max. Number of Sequence Loops when using library commands    | 1012          |
| Max. Number of Sequence Loops when using PMU example library | 10°           |
| Time per Segment   | 20 ns to 40 s |
| Segment Timing Resolution                                    | 10 ns         |

#### **Control Parameters for Each Segment**

Start V Stop V Duration

Measurement window (PMU or PMU+RPM only) Measurement type (PMU or PMU+RPM only)

RMS Jitter (Segment) 0.01% + 200 ps typical

- 1. For multiple 4225-PMU or 4220-PGU cards in a single 4200A-SCS chassis
- 2. Per channel

## 6. Pulse Generator Unit

The two-channel, voltage-only pulse generator is an economical alternative to the 4225-PMU Ultra-fast Pulse Measure Unit if pulse measurement is not needed.

## **4220-PGU General Information**

Output connectors Four SMA (f) SMA (m) to SMA (m), 2 m, 4 each (CA-404B) Supplied cables SMA (m) to SSMC 4-cable, 15 cm (6 in.), 2 each (4200-PRB-C)

## Pulse/Level 1, 2

|   |  | 10V Range   | 40V Range                  |
|---|--|---|----------------------------|
| V   | 50 Ω into 1 MΩ                                   | –10 V to +10 V                                      | -40 V to +40 V             |
| V <sub>OUT</sub>                              | 50 Ω into 50 Ω                                   | −5 V to +5 V  | -20 V to +20 V             |
| Accuracy                                      | _  | ±(0.5% + 10 mV)                                     | ±(0.2% + 20 mV)            |
| Resolution                                    | 50 Ω into 50 Ω                                   | <250 μV   | <750 μV                    |
| nesolution                                    | 50 Ω into 1 MΩ                                   | <0.5 mV   | <1.5 mV                    |
| Overshoot/pre-shoot/ringing <sup>3</sup>      | 50 Ω into 50 Ω                                   | ±(3% + 20 mV)                                       | ±(3% + 80 mV)              |
|   | 50 $\Omega$ into 50 $\Omega$ , typical best case | ±(2% + 20 mV)                                       | ±(0.8% + 40 mV)            |
| Baseline noise                                | _  | ±(0.3% + 1 mV) RMS typical                          | ±(0.1% + 5 mV) RMS typical |
| Source impedance                              | _  | 50 Ω nominal  | 50 Ω nominal               |
| Current into 50 $\Omega$ load (at full scale) | _  | ±100 mA typical                                     | ±400 mA typical            |
| Short circuit current                         | _  | ±200 mA   | ±800 mA                    |
| Output limit                                  | _  | Programmable limit to protect the device under test |                            |

#### Notes

- 1. Unless stated otherwise, all specifications assume a 50  $\Omega$  termination.
- 2. Level specifications are valid after 50 ns typical settling time (after slewing) for the 10 V source range and after 500 ns typical settling time (after slewing) for the 40 V source range into a 50 Ω load.

  3. With transition time of 20 ns (0%–100%) for the 10 V source range and 100 ns (0%–100%) for the 40 V source range.

## **Pulse Timing**

|  | 10 V Range<br>Source Only     | 40 V Range<br>Source Only   |
|--|-------------------------------|-----------------------------|
| Frequency range                        | 1 Hz to 50 MHz                | 1 Hz to 10 MHz              |
| Timing resolution                      | 10 ns                         | 10 ns                       |
| RMS jitter (period, width), typical    | 0.01% + 200 ps                | 0.01% + 200 ps              |
| Period range                           | 20 ns to 1 s                  | 100 ns to 1s                |
| Accuracy                               | ±1%                           | ±1%                         |
| Pulse width range                      | 10 ns to (Period-10 ns)       | 50 ns to (Period-10 ns)     |
| Accuracy                               | ±(1% + 200 ps)                | ±(1% + 5 ns)                |
| Programmable transition time (0%–100%) | 10 ns to 33 ms                | 30 ns to 33 ms <sup>1</sup> |
| Transition slew rate accuracy          | ±1%<br>(transitions > 100 ns) | ±1%<br>(transitions > 1 µs) |
| Solid state relay open/close time      | 25 μs                         | 25 μs                       |

1. 40 V range minimum programmable transition time (source only) is 30 ns for voltage <10 V and 100 ns for voltages >10 V.

#### **Voltage Source, Best Performance**

When the 4225-PMU is used as a voltage source only (no measurements of voltage or current), the timing performance is improved. The following is provided to offer a clearer idea of best performance when used as a voltage source, as achievable under optimal conditions. This should not be interpreted as a guarantee.

|                                | 10 V Range    | 40 V Range                    |
|--------------------------------|---------------|-------------------------------|
| Rise Time                      | <10 ns        | 50 ns to 10 V, 100 ns to 40 V |
| Pulse Width                    | 10 ns (FWHM)  | 50 ns (FWHM)                  |
| Period                         | 20 ns         | 100 ns                        |
| Overshoot/<br>Preshoot/Ringing | ±(2% + 20 mV) | ±(0.5% + 40 mV)               |

| Trigger                                     |         |  |  |
|---|---------|--|--|
| Trigger output impedance                    | 50 Ω    |  |  |
| Trigger output level                        | TTL     |  |  |
| Trigger in impedance                        | 10 kΩ   |  |  |
| Trigger in level                            | TTL     |  |  |
| Trigger in transition timing, maxin         | um      |  |  |
|   | <100 ns |  |  |
| Trigger in to pulse output delay            | 400 ns  |  |  |
| Trigger synchronization/jitter <sup>1</sup> | <2 ns   |  |  |

## Segment ARB® and Timing

Segment ARB capabilities are available with the 4225-PMU and 4220-PGU, with or without the 4225-RPM Remote Preamplifier/Switch Module.

| Max. Number of Segments                                      | 2048 per PMU channel |
|--|----------------------|
| Max. Number of Sequences                                     | 512 per PMU channel  |
| Max. Number of Sequence Loops when using library commands    | 10 <sup>12</sup>     |
| Max. Number of Sequence Loops when using PMU example library | 10 <sup>9</sup>      |
| Time per Segment   | 20 ns to 40 s        |
| Segment Timing Resolution                                    | 10 ns                |

#### **Control Parameters for Each Segment**

Start V Stop V Duration

Measurement window (PMU or PMU+RPM only) Measurement type (PMU or PMU+RPM only)

RMS Jitter (Segment) 0.01% + 200 ps typical

1. For multiple 4225-PMU or 4220-PGU cards in a single 4200A-SCS chassis

## 7. Remote Preamplifier/Switch Module

The 4225-RPM enables automatic switching between I-V, C-V and Pulsed I-V measurements, allowing you to choose the appropriate measurement without recabling your test setup. Additionally, the RPM expands the range of the 4225-PMU Pulse Measure Module.

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#### 4225-RPM General Information

| Inputs               | Three inputs. SMU Force, SMU Sense, CVU Pot, CVU Cur, R  |
|----------------------|--|
| Outputs              | One channel  |
| Input connector      | Triaxial (f), two<br>SMA (f), two<br>HDMI  |
| Output connector     | Triaxial (f), two  |
| Dimensions           | 1.34 in. wide $\times$ 4.9 in. deep $\times$ 3.0 in. tall (3.4 cm wide $\times$ 12.5 cm deep $\times$ 7.6 cm tall) |
| Dimensions with base | 1.34 in. wide $\times$ 4.9 in. deep $\times$ 3.8 in. tall (3.4 cm wide $\times$ 12.5 cm deep $\times$ 9.6 cm tall) |
| Weight               | 8.6 oz. (245 g) (with base: 13.4 oz. (381 g))  |
| Optional Accessories | Magnetic base  |
|                      |  |

#### **RPM Current Measurement**

Timing parameters, typical 1 with the 4225-PMU and 4225-RPM Remote Preamplifier/Switch Module

|   |        |         | 10V F   | Range   |        |        |
|---|--------|---------|---------|---------|--------|--------|
| Current measure ranges                                | 100 nA | 1 μΑ    | 10 µA   | 100 μΑ  | 1 mA   | 10 mA  |
| Recommended minimum pulse width 2                     | 134 µs | 20.4 μs | 8.36 µs | 1.04 µs | 370 ns | 160 ns |
| Recommended<br>minimum<br>measure window <sup>2</sup> | 10 µs  | 1.64 µs | 1 µs    | 130 ns  | 40 ns  | 20 ns  |
| Recommended minimum transition time <sup>3</sup>      | 1 µs   | 360 ns  | 360 ns  | 40 ns   | 30 ns  | 20 ns  |
| Noise 4   | 200 pA | 2 nA    | 5 nA    | 50 nA   | 300 nA | 1.5 µA |
| Settling time 5                                       | 100 µs | 15 µs   | 6 µs    | 750 ns  | 250 ns | 100 ns |

#### Notes

- 1. All typical values measured with an open circuit.
- 2. Using default measure window of 75% to 90% of pulse top. Recommended minimum pulse width = (Settling Time) / 75%.
- Recommended rise/fall time to minimize overshoot.
- 4. RMS noise measured over the Recommended Minimum Measure Window for the given voltage or current range, typical.
- 5. Time necessary for the signal to settle to the DC accuracy level. (Example: 10 mA settling time on the PMU 10 V range is defined when the signal is within 1.25% of the final value. This calculation: Accuracy =  $0.25\% + 100 \mu A = 0.25\% + (100 \mu A/10 mA) = 0.25\% + 1\% = 1.25\%$ ).

## **Current Measurement Accuracy**

#### 4225-PMU and RPM Combined

|                        | 10 V Range     |                |                 |                  |                |                |
|------------------------|----------------|----------------|-----------------|------------------|----------------|----------------|
| Current measure ranges | 100 nA         | 1 μΑ           | 10 μA           | 100 μΑ           | 1 mA           | 10 mA          |
| Accuracy (DC)          | ±(0.5% + 1 nA) | ±(0.5% + 1 nA) | ±(0.5% + 30 nA) | ±(0.5% + 100 nA) | ±(0.5% + 1 μA) | ±(0.5% +10 μA) |

## Pulse/Level 1

| Pulse/Level <sup>1</sup>                 | 4225-PMU with 4225-RPM      |
|--|-----------------------------|
| V <sub>OUT</sub>                         | –10 V to +10 V              |
| Accuracy <sup>2</sup> into open load     | ±(0.5% ± 10 mV)             |
| Resolution                               | <0.05 mV                    |
| Baseline noise                           | ±(0.39% ± 1 mV) RMS typical |
| Overshoot/Pre-shoot/Ringing <sup>3</sup> | ±2% of amplitude ±20 mV     |

#### Notes

- 1. Performance at the triax output connection of the 4225-RPM when using a 2 m RPM interconnect cable between the 4225-PMU and 4225-RPM Remote Preamplifier/Switch Module.
- 2. 100 mV to 10 V.
- 3. Typical, with transistion time of 100 ns (0% to 100%).

## **RPM Voltage Measurement with the 4225-PMU**

#### Timing parameters, typical 1

|  | 4225-RPM |
|--|----------|
| Voltage measure range                        | 10 V     |
| Recommended minimum pulse width <sup>2</sup> | 160 ns   |
| Recommended minimum measure window 2         | 20 ns    |
| Recommended minimum transition time 3        | 20 ns    |
| Noise 4                                      | 1 mV     |
| Settling time 5                              | 100 ns   |

- 1. All typical values measured with an open circuit.
- $2. \ \ Using default measure window of 75\% to 90\% of pulse top. Recommended minimum pulse width = (Settling Time) / 75\%.$
- 3. Recommended rise/fall time to minimize overshoot.
- 4. RMS noise measured over the Recommended Minimum Measure Window for the given voltage or current range, typical.
- 5. Time necessary for the signal to settle to the DC accuracy level. (Example: 10 mA settling time on the PMU 10 V range is defined when the signal is within 1.25% of the final value. This calculation: Accuracy = 0.25% + 100 μA = 0.25% + (100 μA/10 mA) = 0.25% + 1% = 1.25%).

## 8. Switch Matrix Configurations

## Ultra-Low Current/Local Sense Configuration (4200-UL-LS-24)

The Ultra Low Current/Local Sense switch configuration is built using two Keithley 7174A Low Current Matrix Cards with the 707B Switch Matrix. These switch cards are designed for semiconductor research, development, and production applications requiring high quality, high performance switching of I-V and C-V signals. This configuration provides eight instrument inputs and 24 output pins at only 10 fA typical offset current. Additional cards can be added to provide up to 72 output pins.

| <b>General Information</b> |                           |
|----------------------------|---------------------------|
| Connector Type             | 3-lug triax               |
| Maximum Signal Level       | 200 V, 2 A                |
| Offset Current             | 100 fA max, 10 fA typical |
| Maximum Leakage            | 0.01 pA/V                 |
| 3 dB Bandwidth             | 30 MHz typical            |
| Package Contents           |                           |
|                            | (1) 707B Switch Mainframe |
|                            | (2) 7174A Switch Cards    |
|                            | (24) 4200-TRX-3 Cables    |
|                            | (1) 7007-1 IEEE-488 Cable |
|                            | (2) 7078-TRX-BNC Adapter  |

## Low Current/Local Sense Configuration (4200-LC-LS-24)

The Low Current/Local Sense switch configuration is built using the Keithley 7072 Semiconductor Matrix Card, which is designed for semiconductor applications requiring good quality I-V and C-V signals. The configuration provides eight instrument inputs with 24 output pins with less than 1 pA output current. Additional cards can be added to provide up to 72 output pins.

| General Information  |                             |
|----------------------|-----------------------------|
| Connector Type       | 3-lug triax                 |
| Maximum Signal Level | 200 V, 1 A                  |
| Offset Current       | <1 pA (Rows A to B)         |
| Maximum Leakage      | 0.1 pA/V                    |
| 3 dB Bandwidth       | 5 MHz typical (Rows G to H) |
| Package Contents     |                             |
|                      | (1) 707B Switch Mainframe   |
|                      | (2) 7072 Switch Cards       |
|                      | (24) 4200-TRX-3 Cables      |
|                      | (1) 7007-1 IEEE-488 Cable   |
|                      | (2) 7078-TRX-BNC Adapter    |

## 9. NBTI/PBTI Capability

The BTI capability on the 4200A-SCS combines advanced DC I-V and ultra-fast I-V measurement capabilities of Keithley with ACS test executive software to provide the most advanced NBTI/PBTI test platform available in the semiconductor test industry. This solution provides all of the instruments, interconnects, and software needed to make the most sophisticated NBTI and PBTI measurements on leading-edge silicon CMOS technology.

#### 4200A-SCS with ACS Standard

Offers the best high-speed, low-current measurement sensitivity available in a single-box integrated solution.

Ensures that source/measure instrumentation will not be the limiting factor when making low-level measurements.

The ACS software supports building complex test sequences, including up to 20 measurement sequences and full prober integration. It also:

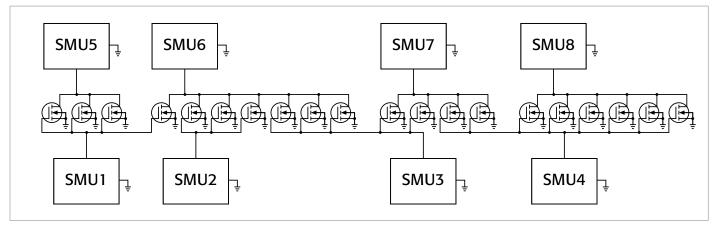
- Easily integrates DC I-V and ultra-fast I-V measurements into a pre- and post-stress measurement sequence.
- Characterizes degradation and recovery behaviors using either AC or DC stress.
- Incorporates single pulse charge trapping (SPCT) measurements into longer stress-measure sequences.
- 4225-PMU and 4225-RPMs include all necessary cabling.
- ACS software includes the ultra-fast BTI test project module.

#### Ultra-fast NBTI/PBTI Capability Requires:

(1) 4225-PMU Ultra-Fast I-V Module

(2) 4225-RPM Remote Preamplifier/Switch Modules

ACS-STANDARDFL Automated Characterization Suite (ACS) Software



Example of using eight SMUs to stress 20 devices in parallel for HCI and NBTI. A separate ground unit (GNDU) is used for common terminals.

## 10. Clarius+ Software

Clarius+ software provides a variety of tools for operating and maintaining the 4200A-SCS parameter analyzer.

| Furnished Software Mod              | lules  |
|-------------------------------------|--|
| Clarius                             | The graphical user interface for testing and characterizing your devices, materials and processes. Clarius software provides a unified measurement interface that guides you through complex characterization tests, enabling you to focus on your research or development projects.   |
| Keithley User Library Tool (KULT)   | Assists test engineers to create custom test routines as well as use existing Keithley and third-party C-language subroutine libraries. Users can edit and compile subroutines, then integrate libraries of subroutines with Clarius, allowing the 4200A-SCS to control an entire test rack from a single user interface   |
| Keithley External Control Interface | e (KXCI) Controls the 4200A-SCS from an external computer via GPIB bus or Ethernet.  |
| Keithley Configuration Utility (KCo | Allows test engineers to define the configuration of GPIB instruments, switch matrices, and analytical probers connected to the 4200A-SCS. It also provides diagnostic functions.  |
| KPulse                              | A graphical user interface that is a non-programming alternative to configure and control the installed 4225-PMU or 4220-PGU pulse generator modules. It is used for quick tests requiring minimal interaction with other 4200A-SCS test resources.  |
| Clarius User Interface Se           | oftware  |
|                                     | Clarius is the resident user interface software running on the 4200A-SCS. Clarius runs on the embedded Windows 10 operating system. It provides test plan selection and development, advanced test configurations, parameter analysis and graphing, and automation capabilities required for modern semiconductor device, materials and process characterization.  |
| Data Analysis                       | Two methods of parameter extraction are available. The Formulator executes data transformations for performing automated line fits and parameter extraction. A spreadsheet offers standard spreadsheet analysis tools. Many of the sample libraries include parameter extraction examples.   |
| Formulator                          | The Formulator supports mathematical functions, conversion functions, search functions, common industry constants and line fit/parameter extraction functions. The Formulator supports the following functions:  |
| Mathematical Functions              | Addition (+), subtraction (-), division (/), multiplication (*), exponent (^), absolute value (ABS), value at an index position (AT), average (AVG), moving average (MAVG), conditional computation (COND), derivative (DELTA), differential coefficient (DIFF), exponential (EXP), square root (SQRT), natural logarithm (LN), logarithm (LOG), integral (INTEG), standard deviation (STDEV), moving summation (SUMMV), arc cosine (ACOS), arc sine (ASIN), arc tangent (ATAN), cosine (COS), sine (SIN), tangent (TAN)   |
| Conversion Functions                | Radians to degrees (DEG), degrees to radians (RAD)   |
| Line Fits and Parameter Extraction  | n Functions  |
|                                     | Exponential line fit (EXPFIT), coefficient a (EXPFITA), coefficient b (EXPFITB), linear fit (LINFIT), linear slope (LINFITSLP), x intercept (LINFITXINT), y intercept (LINFITYINT), logarithmic line fit (LOGFIT), coefficient a (LOGFITA), coefficient b (LOGFITB), linear regression line fit (REGFIT), slope (REGFITSLP), x intercept (REGFITXINT), y intercept (REGFITYINT), tangent line fit (TANFIT), slope (TANFITSLP), x intercept (TANFITXINT), y intercept (TANFITXINT), polynomial line fit including POLYFIT2, POLY2COEFF, and POLYNFIT, maximum value (MAX), minimum value (MIN), midpoint (MEDIAN) |
| Search Functions                    | Find down (FINDD), find up (FINDU), find using linear interpolation (FINDLIN), maximum position (MAXPOS), minimum position (MINPOS), first position (FIRSTPOS), last position (LASTPOS), sub array (SUBARRAY), return a specified number of points (INDEX)   |
| FFT Analysis Functions              | FFT real components (FFT_R), FFT imaginary components (FFT_I), inverse FFT real components (IFFT_R), Inverse FFT imaginary components (IFFT_I), get FFT frequencies (FFT_FREQ), get positive FFT frequencies (FFT_FREQ_P), digital smoothing (Smooth)  |

## **Formulator Constants** The Formulator supports user-supplied constants for use in parameter extractions. These constants are factory installed: $PI = 3.14159 \text{ rad } (\pi)$ $K = 1.38065 \times 10^{-23} \text{ J/K (Boltzmann's constant)}$ $Q = 1.60218 \times 10^{-19} C$ (Charge of electron) $M_0 = 9.10938 \times 10^{-31} \text{ kg (Electron mass)}$ $E_V = 1.60218 \times 10^{-19} \text{ J (Electron Voltage)}$ $U_0 = 1.25664 \times 10^{-6} \text{ N/A}^2 \text{ (Permeability)}$ $E_0 = 8.85419 \times 10^{-12}$ F/m (Permittivity of a Vacuum) $H = 6.62607 \times 10^{-34} \text{ m}^2 \cdot \text{kg/s}$ (Planck's constant) $C = 2.99792 \times 10^{+8} \text{ m/s}$ (Speed of light) KT/Q = 0.02568 V (Thermal Voltage) **Automation Test Sequencing** Clarius provides point-and-click test sequencing on a device, a group of devices (subsite, module, or test element group), or a user-programmable number of probe sites on a wafer. **Prober Control** Keithley provides integrated prober control for supported analytical probers when test sequencing is executed on a user-programmable number of probe sites on a wafer. Contact the factory for a list of supported analytical probers. A manual prober mode prompts the operator to perform prober operations during the test sequence. Supported Probers Manual Prober Use the manual prober driver to test without utilizing automatic prober functionality. Manual prober replaces all computer control of the prober with that of the operator. At each prober command, a dialog

#### Supported Semi-automatic (Analytical) Probers

remove prober commands from a sequence.

box appears, instructing the operator what operation is required.

FormFactor (formerly Cascade Microtech) Summit™ 12K Series - Verified with Nucleus UI, compatible with Velox

Karl Suss Model PA-200 - Verified with Wafermap for ProberBench NT, NI-GPIB Driver for ProberBench NT, PBRS232 Interface for ProberBench NT, Navigator for ProberBench NT, Remote Communicator for ProberBench NT

The Fake prober is useful when prober actions are not desired, such as when debugging, without having to

 ${\it MicroManipulator~8860~Prober~-~Verified~with~pcBridge,~pcLaunch,~pcIndie,~pcWfr,~pcNav,~pcRouter}$ 

MPI TS2000 and TS3000 Probers - Verified with MPI Sentio Software Suite version 2.9

Signatone CM500 driver also works with other Signatone probers with interlock controller such as the WL250 and S460SE

Wentworth Laboratories Pegasus™ FA Series

SemiProbe Probe System for Life (PS4L) semiautomatic and fully automatic probers and Pilot software Other probers supported but not listed

Supported Cryogenic Temperature Controllers

LakeShore Model 336 Cryogenic Temperature Controller

#### **Keithley User Library Tool (KULT)**

The Keithley User Library Tool supports creating and integrating C-language subroutine libraries with the test environment. User library modules are accessed in Clarius through User Test Modules. Factory supplied libraries provide up and running capability for supported instruments. Users can edit and compile subroutines, then integrate libraries of subroutines with Clarius, allowing the 4200A-SCS to control an entire test rack from a single user interface.

#### System Configuration and Diagnostics (KCon)

The Keithley Configuration Utility (KCon) simplifies programming and maintaining a fully integrated test station. KCon provides a single interface for configuring external instruments, switch matrices, and analytical probers, and for executing system diagnostics.

External Instrument Configuration KCon allows lab managers to integrate external instruments with the 4200A-SCS and a supported switch matrix. After the user configures the GPIB addresses for supported instruments, Keithley-supplied libraries will function and test modules can be transferred between 4200A-SCS systems without any user modification. In addition to the standard supported instruments, the General Purpose Instrument allows users to develop subroutines and control switches for a generic two-terminal or four-terminal instrument. For the widest possible system extensibility, users can develop their own test libraries for general purpose instruments.

> Outside of KCon, users can configure GPIB or USB control of simple instruments, switches, lamps, etc. with included user libraries.

#### **Switch Matrix Configuration**

Users define the connection of 4200A-SCS instruments and external instruments to device under test (DUT) pins through a supported switch matrix configuration. (See Switch Matrix Support and Configurations.) Once connections are defined, users need only enter the instrument terminal name and pin number to establish connections. The 4200A-SCS applications and standard user libraries manage the routing of test signals between instrument terminals and DUT pins. The user doesn't need to remember and program row and column closures. Test modules can transfer between 4200A-SCS systems without re-entering connection information.

#### 4200A-SCS Instrument Diagnostics

Users can confirm system integrity of SMUs, C-V measurement unit, pulse generator, oscilloscopes, and remote preamplifiers by running a system self-test. For more complex problems, the system's configuration analysis tool can generate reports that assist the Technical Support staff of Keithley in diagnosing problems.

#### Keithley External Control Interface (KXCI)

With KXCI, you can use an external computer to control the SMUs and CVU modules in the 4200A-SCS directly. KXCI also provides you with indirect control of the Ultra-fast I-V Pulse Measure Unit, using UTMs via either the built-in GPIB or Ethernet. For the SMUs, the KXCI command set includes an HP 4145 compatibility mode, allowing many programs already developed for the HP4145 to use the 4200A-SCS instead.

# 11. Supplied Accessories

| 4200A-SCS                       | Parameter Analyzer Mainframe   |  |  |  |  |
|---------------------------------|--|--|--|--|--|
|                                 | (1) 236-326A Interlock Cable, 3 m (10 ft)  |  |  |  |  |
|                                 | (2) 4200-TRX-2 Ultra Low Noise Triax Cables, 2 m (6.6 ft)  |  |  |  |  |
| 4200-SMU                        | Medium Power Source-Measure Unit for 4200A-SCS, 100 mA to 100 fA, 200 V to 0.2 μV, 2 Watts   |  |  |  |  |
| If configured with a preamp:    | All cables are provided with the 4200-PA. See 4200-PA below.   |  |  |  |  |
| If configured without a preamp: | (2) 4200-MTRX-2 Mini Ultra Low Noise Triax Cables, 2 m (6.6 ft)  |  |  |  |  |
|                                 | Not recommended for new designs.   |  |  |  |  |
| 4201-SMU                        | Medium Power Source-Measure Unit for 4200A-SCS and high-capacitance setups, 100 mA to 100 fA, 200 V to 0.2 $\mu$ V, 2 Watts, 10 $\mu$ F load capacitance |  |  |  |  |
| If configured with a preamp:    | All cables are provided with the 4200-PA. See 4200-PA below  |  |  |  |  |
| If configured without a preamp: | (2) 4200-MTRX-2 Mini Ultra Low Noise Triax Cables, 2 m (6.6 ft)  |  |  |  |  |
| 4210-SMU                        | High Power Source-Measure Unit for 4200A-SCS, 1 A to 100 fA, 200 V to 0.2 μV, 20 Watts   |  |  |  |  |
| If configured with a preamp:    | All cables are provided with the 4200-PA. See 4200-PA below.   |  |  |  |  |
| If configured without a preamp: | (2) 4200-MTRX-2 Mini Ultra Low Noise Triax Cables, 2 m (6.6 ft)  |  |  |  |  |
|                                 | Not recommended for new designs.   |  |  |  |  |
| 4211-SMU                        | High Power Source-Measure Unit for 4200A-SCS and high-capacitance setups, 1 A to 100 fA, 200 0.2 $\mu$ V, 2 Watts, 100 $\mu$ F load capacitance          |  |  |  |  |
| If configured with a preamp:    | All cables are provided with the 4200-PA. See 4200-PA below  |  |  |  |  |
| If configured without a preamp: | (2) 4200-MTRX-2 Mini Ultra Low Noise Triax Cables, 2 m (6.6 ft)  |  |  |  |  |
| 4200-PA                         | Remote Preamp Option for 4201, 4211, 4200, and 4210 SMUs, extends SMU to 0.01 fA resolution  |  |  |  |  |
|                                 | (1) 4200-RPC remote preamp cable, 3 m (9.8 ft)   |  |  |  |  |
|                                 | (2) 4200-TRX-2 Ultra Low Noise Triax Cables, 2 m (6.6 ft)  |  |  |  |  |
| 4215-CVU                        | High Resolution Capacitance Voltage (C-V) Module   |  |  |  |  |
|                                 | (4) CA-447A SMA Cables, male to male, 100 $\Omega$ , 1.5 m (5 ft)  |  |  |  |  |
|                                 | (4) CS-1247 Female SMA to Male BNC Adapters  |  |  |  |  |
|                                 | (2) CS-701 BNC Tee Adapters  |  |  |  |  |
| 4225-PMU                        | Ultra-Fast Pulse Measure Unit  |  |  |  |  |
|                                 | (4) CA-404B SMA-to-SMA 50 $\Omega$ cables, 2 m (6.6 ft)  |  |  |  |  |
|                                 | (2) 4200-PRB-C SMA-to-SSMC Y-Cable Assembly, 15 cm (6 in.)   |  |  |  |  |
| 4225-RPM                        | Remote Preamplifier/Switch Module  |  |  |  |  |
|                                 | (1) CA-452A SMA-to-SMA 50 Ω Cable, 20 cm (7.9 in)  |  |  |  |  |
|                                 | (1) 7078-TRX-BNC Triax-to-BNC Adapter  |  |  |  |  |
|                                 | (1) CS-1247 BNC-to-SMA Adapter   |  |  |  |  |
|                                 | (1) CA-547-2A RPM Cable, 2.1 m (6.9 ft)  |  |  |  |  |
|                                 |  |  |  |  |  |

| 4220-PGU   | High Voltage Pulse Generator  |
|------------|---|
|            | (4) CA-404B SMA-to-SMA 50 $\Omega$ cables, 2 m (6.6 ft)   |
|            | (2) 4200-PRB-C SMA-to-SSMC Y-Cable Assembly, 15 cm (6 in.)  |
| 4200A-CVIV | I-V, C-V Multi-switch Module  |
|            | (2) 4200A-CVIV-SPT SMU Pass-Thru Modules  |
|            | (2) 214543500 Slot Blockers   |
|            | (1) 174691500 USB Cable   |
|            | (1) 4200-MTRX-2 Mini Ultra Low Noise Triax Cable, 2 m (6.6 ft)                                      |
|            | NOTE: For each SMU connected through the 4200A-CVIV, one 4200A-CVIV-SPT or one 4200-PA is required. |
| 707B       | 6-slot Switching Matrix Mainframe   |
| 707B       | 6-slot Switching Matrix Mainframe   |
|            | CA-180-4A CAT 5 Ethernet Crossover Cable, 1 m (3.3 ft)  |
|            | CA-179-2A CAT 5 Ethernet Cable 3 m (10 ft)  |
|            | CO-7 Line Cord  |
|            | Rear Fixed Rack Mount Hardware  |
| 708B       | Single-slot Switching Matrix Mainframe  |
|            | CA-180-4A CAT 5 Ethernet Crossover Cable, 1 m (3.3 ft)  |
|            | CA-179-2A CAT 5 Ethernet Cable 3 m (10 ft)  |
|            | CO-7 Line Cord  |
| 7072       | 8×12, Semiconductor Matrix Card   |
| 7174A      | 8×12, High Speed, Low Leakage Current, Matrix Card  |

# 12. Optional Accessories

| Connectors and Ad  | Connectors and Adapters   |  |  |
|--|---|--|--|
| CS-565   | Female BNC to Female BNC Adapter                                |  |  |
| CS-701   | BNC Tee Adapter (female, male, female)                          |  |  |
| CS-719   | 3-lug Triax Jack Receptacle                                     |  |  |
| CS-1247  | SMA Female to BNC Male Adapter                                  |  |  |
| CS-1249  | SMA Female to SMB Plug Adapter                                  |  |  |
| CS-1251  | BNC Female to SMB Plug Adapter                                  |  |  |
| CS-1252  | SMA Male to BNC Female Adapter                                  |  |  |
| CS-1281  | SMA Female to SMA Female Adapter                                |  |  |
| CS-1390  | Male LEMO Triax to Female SMA Adapter                           |  |  |
| CS-1391  | SMA Tee Adapter (female, male, female)                          |  |  |
| CS-1479  | SMA Male to BNC Male Adapter                                    |  |  |
| 237-BAN-3A   | Triax Cable Center Conductor terminated in a safety banana plug |  |  |
| 237-BNC-TRX  | Male BNC to 3-lug Female Triax Adapter                          |  |  |
| 237-TRX-BAR  | 3-lug Triax Barrel Adapter (female to female)                   |  |  |
| 237-TRX-T  | 3-slot Male to Dual 3-lug Female Triax Tee Adapter              |  |  |
| 7078-TRX-BNC   | 3-slot Male Triax to BNC Adapter                                |  |  |
| 7078-TRX-GND   | 3-slot Male Triax to Female BNC Connector (guards removed)      |  |  |
| Test Fixtures  |   |  |  |
| 8101-PIV   | Pulse I-V Demo Fixture  |  |  |
| Cabinet Mounting Accessories   |   |  |  |
| 4200A-RM   | Fixed Cabinet Mount Kit for 4200A-SCS                           |  |  |
| Cables and Cable Sets  NOTE: All 4200A-SCS systems and instrument options are supplied with required cables, 3 m (9.8 ft.) length. |   |  |  |
| CA-19-2  | BNC to BNC Cable, 1.5 m   |  |  |
| CA-404B  | SMA to SMA Coaxial Cable, 2 m                                   |  |  |
| CA-405B  | SMA to SMA Coaxial Cable, 15 cm                                 |  |  |
| CA-406B  | SMA to SMA Coaxial Cable, 33 cm                                 |  |  |
| CA-446A  | SMA to SMA Coaxial Cable, 3 m                                   |  |  |
| CA-447A  | SMA to SMA Coaxial Cable, 1.5 m                                 |  |  |
| CA-451A  | SMA to SMA Coaxial Cable, 10.8 cm                               |  |  |
| CA-452A  | SMA to SMA Coaxial Cable, 20.4 cm                               |  |  |

| 236-326A              | Interlock Cable, 3 m (10 ft) Note: Replacement interlock cables must be ordered through Keithley Service Department.                          |
|-----------------------|---|
| 237-ALG-2             | Low Noise Triax Input Cable terminated with 3 alligator clips, 2 m  |
| 4210-MMPC-C           | Multi-Measurement (I-V, C-V, Pulse) Prober Cable Kit for Cascade Microtech 12000 prober series  |
| 4210-MMPC-S           | Multi-Measurement (I-V, C-V, Pulse) Prober Cable Kit for SUSS MicroTec PA200/300 prober series  |
| 4210-MMPC-L           | Multi-Measurement (I-V, C-V, Pulse) Prober Cable Kit for Lucas Signatone probers  |
| 4210-MMPC-W           | Multi-Measurement (I-V, C-V, Pulse) Prober Cable Kit for Wentworth Laboratories probers   |
| 4200-MTRX-*           | Ultra Low Noise SMU Triax Cable: 1 m, 2 m, and 3 m options  |
| 4200-RPC-2            | Remote Preamp Cable, 2 m  |
| 4200-TRX-*            | Ultra Low Noise Preamp Triax Cable: 0.3 m, 0.75 m, 2 m, 3 m options   |
| CA-300-1A             | Double-Shielded Premium GPIB Cable, 1 m   |
| CA-300-2A             | Double-Shielded Premium GPIB Cable, 2 m   |
| Adapter, Cable, and S | Stabilizer Kits   |
| 4200-CVU-PWR          | CVU Power Package for ±200 V C-V  |
| 4200-CVU-PROBER-KIT   | Accessory Kit for connection to popular analytical probers  |
| 4200-PMU-PROBER-KIT   | General Purpose Cable/Connector Kit. For connecting the 4225-PMU to most triax and coax probe stations. One kit required per 4225-PMU module. |
| Software              |   |
| ACS-BASICFL           | Component Characterization Software   |
| ACS-STANDARDFL        | Advanced Component Characterization Software  |
| Other Accessories     |   |
| EM-50A                | Modified Power Splitter   |
| TL-24                 | SMA Torque Wrench   |
| 4200A-CASE            | Transport Case for 4200A-SCS  |
|                       |   |

# 13. General Specifications

| Mainframe Display           | 15.6 in. LCD, capacitive touchscreen<br>1920 × 1080 full HD<br>10 point touch   |
|-----------------------------|---|
| External Display            | External VGA, HDMI, or Display Port: The system is designed to work with an external monitor of resolution $1920 \times 1080$   |
| Temperature Range           | Operating: +10° to +40°C<br>Storage: -15° to +60°C  |
| Humidity Range              | Operating: 5% to 80% RH, non-condensing Storage: 5% to 90% RH, non-condensing   |
| Altitude                    | Operating: 0 to 2000 m<br>Storage: 0 to 4600 m  |
| Power Requirements          | 100 V to 240 V, 50 to 60 Hz   |
| Maximum VA                  | 1000 VA   |
| Regulatory Compliance       | Safety: European Low Voltage Directive. NRTL listed by Intertek for the US and Canada. EMC: European EMC Directive  |
| Dimensions                  | 43.6 cm wide $\times$ 22.3 cm high $\times$ 56.5 cm deep (17 $^{5}$ / $_{32}$ in $\times$ 8 $^{3}$ / $_{4}$ in $\times$ 22 $^{1}$ / $_{4}$ in)  |
| Weight (approx.)            | 29.7 kg (65.5 lb) for typical configuration of four SMUs  |
| I/O Ports                   | USB, SVGA, Display Port, RS-232, GPIB, Ethernet, mouse, keyboard, audio   |
| Ground Unit                 | Voltage error when using the ground unit is included in the 4200-SMU, 4210-SMU, and 4200-PA specifications. No additional errors are introduced when using the ground unit.   |
| Output Terminal Connection  | Dual triaxial, 5-way binding post   |
| Maximum Current             | 2.6 A using dual triaxial connection; 9.5 A using 5-way binding posts   |
| Load Capacitance            | No limit  |
| Cable Resistance            | FORCE $\leq$ 1 $\Omega$ , SENSE $\leq$ 10 $\Omega$  |
| LCD Display Pixel Guideline | LCD displays are made up of a matrix of pixels, with each pixel consisting of red, green, and blue sub-pixels. These pixels and sub-pixels can become fixed in an unchanging state resulting in permanently black, white, or colored spots on the display. These are typically categorized as Bright or Black pixel (or dot) defects. |
|                             | Bright dot defect: A dot that is always lit, either as a white or colored dot, visible on a black check pattern.  |
|                             | Black dot defect: A dot that appears as either black or purple (magenta) on red, green, and/or blue check patterns.   |
|                             | The LCD display used in the 4200A-SCS is permitted to have a maximum of 6 (six) bright dot defects upon receipt of a new instrument. A maximum of three bright dot defect pairs (adjacent defective dots) are permitted. Three adjacent bright dots are not permitted under the pixel guideline.                                      |
|                             | The LCD display is permitted to have a maximum of 5 (five) black dot defects. Two adjacent black dot defects are to be counted as a single black dot defect. A maximum of three black dot defect pairs (adjacent defective dots) are permitted. Three adjacent black dot defects are not permitted under the pixel guideline.         |
|                             |   |

# 14. Ordering Information

| Mainframes          |   |
|---------------------|---|
| 4200A-SCS           | Parameter Analyzer with 15.6" LCD display   |
| 4200A-SCS-ND        | Parameter Analyzer without LCD display  |
| Instruments/Modules |   |
| 4200-PA             | Remote SMU Preamplifier Module  |
| 4200-SMU            | Medium Power Source Measure Unit  |
| 4200-SMU-R          | Field Installable, Medium Power Source Measure Unit   |
| 4200-SMU/PA-R       | Field Installable, Medium Power Source Measure Unit with Preamplifier                             |
| 4201-SMU            | Medium power Source Measure Unit for high-capacitance setups                                      |
| 4201-SMU-R          | Field installable medium power Source Measure Unit for high-capacitance setups                    |
| 4201-SMU/PA-R       | Field Installable, medium Power Source Measure Unit for high-capacitance setups with Preamplifier |
| 4210-SMU            | High Power Source Measure Unit  |
| 4210-SMU-R          | Field Installable, High Power Source Measure Unit   |
| 4210-SMU/PA-R       | Field Installable, High Power Source Measure Unit with Preamplifier                               |
| 4211-SMU            | High power Source Measure Unit for high-capacitance setups  |
| 4211-SMU-R          | Field installable high power Source Measure Unit for high-capacitance setups                      |
| 4211-SMU/PA-R       | Field Installable, high power Source Measure Unit for high-capacitance setups with Preamplifier   |
| 4215-CVU            | High Resolution Multi-frequency C-V Unit  |
| 4225-PMU            | Ultra-fast Pulsed I-V Unit  |
| 4220-PGU            | Pulse Generator Unit  |
| 4225-RPM            | Remote Preamplifier/Switch Module   |
| 4200A-CVIV          | CVIV Multi-Switch Module  |
| 4200-CVU-PWR        | C-V Power Package   |
| Mainframe Options   |   |
| 4200A NOACRONIS     | Do not install backup software  |
| C/NEW DATA ISO      | Include ISO-17025 calibration data  |
|                     |   |

## 15. Configured Packages

| 4200A-SCS-PKA High Resolution I-V         |   |  |  |
|---|---|--|--|
| 4200A-SCS                                 | Parameter Analyzer mainframe                      |  |  |
| 4201-SMU                                  | Two medium power SMUs for high capacitance setups |  |  |
| 4200-PA                                   | One preamplifier                                  |  |  |
| 8101-PIV                                  | One test fixture with sample devices              |  |  |
| 4200A-SCS-PKB High Resolution I-V and C-V |   |  |  |
| 4200A-SCS                                 | Parameter Analyzer mainframe                      |  |  |
| 4201-SMU                                  | Two medium power SMUs for high capacitance setups |  |  |
| 4200-PA                                   | One preamplifier                                  |  |  |
| 4215-CVU                                  | One high resolution multi-frequency C-V unit      |  |  |
| 8101-PIV                                  | One test fixture with sample devices              |  |  |
| 4200A-SCS-PKC High Power I-V and C-V      |   |  |  |
| 4200A-SCS                                 | Parameter Analyzer mainframe                      |  |  |
| 4201-SMU                                  | Two medium power SMUs for high capacitance setups |  |  |
| 4211-SMU                                  | Two high power SMUs for high capacitance setups   |  |  |
| 4200-PA                                   | two preamplifier                                  |  |  |
| 4215-CVU                                  | One high resolution multi-frequency C-V unit      |  |  |
| 8101-PIV                                  | One test fixture with sample devices              |  |  |

## 16. Upgrading the 4200A-SCS Parameter Analyzer

Besides adding instrument modules to your parameter analyzer, there are other upgrade options available to keep your parameter analyzer up-to-date with the latest technologies and applications tests.

| 4200A-MF-UP               | This upgrade service will convert any 4200-SCS mainframe to the 4200A-SCS widescreen mainframe with Clarius+ software. Any instrument modules in the 4200-SCS will be moved to the 4200A-SCS mainframe and the system will receive a factory calibration and a one year warranty on the mainframe.                |
|---------------------------|---|
| 4200A-IFC                 | Required installation and factory calibration service when any instrument module is added to the 4200A-SCS mainframe. Only one 4200A-IFC is required per instrument module upgrade order. Not required when ordering the 4200A-MF-UP.   |
| 4200A-WIN10-DRV           | Replace hard disk inside the 4200A-SCS unit with a new Windows 10 disk. Requires unit to be shipped back to the factory. This upgrade can be ordered with the -NOACRONIS option to remove the Acronis backup software from the 4200A-SCS. Do not add 4200A-IFC unless instrument modules are being added as well. |
| 4200-SMU-MOD/4210-SMU-MOD | Modernize an older SMU in order to add new SMUs to the same system. Should not be ordered with 4200A-MF-UP.   |

## 17. Warranty Information

#### **Warranty Summary**

This section summarizes the warranties of the 4200A-SCS. Any portion of the product that is not manufactured by Keithley is not covered by this warranty and Keithley will have no duty to enforce any other manufacturer's warranties.

#### **Hardware Warranty**

Keithley Instruments warrants the Keithley manufactured portion of the hardware for a period of one year from defects in materials or workmanship; provided that such defect has not been caused by use of the Keithley hardware which is not in accordance with the hardware instructions. The warranty does not apply upon any modification of Keithley hardware made by the customer or operation of the hardware outside the environmental specifications.

#### **Software Warranty**

Keithley warrants for the Keithley produced portion of the software or firmware will conform in all material respects with the published specifications for a period of ninety (90) days; provided the software is used on the product for which it is intended in accordance with the software instructions. Keithley does not warrant that operation of the software will be uninterrupted or error-free, or that the software will be adequate for the customer's intended application. The warranty does not apply upon any modification of the software made by the customer.

## 18. Embedded Computer Policy

CAUTION: If you install software that is not part of the standard application software for the 4200A-SCS, the non-standard software may be removed if the instrument is sent in for service. Back up the applications and any data related to them before sending the instrument in for service.

CAUTION: Do not reinstall or upgrade the Microsoft® Windows® operating system (OS) on any 4200A-SCS. This action should only be performed at an authorized Keithley Instruments service facility. Violation of this precaution will void the 4200A-SCS warranty and may render the 4200A-SCS unusable. Any attempt to reinstall or upgrade the operating system (other than a Windows service pack update) will require a return-to-factory repair and will be treated as an out-of-warranty service, including time and material charges.

Although you must not attempt to reinstall or upgrade the operating system, you can restore the hard drive image (complete with the operating system) using the Acronis True Image OEM software tool, included with the 4200A-SCS.

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